

## ISL73847M

Radiation Tolerant Single/Dual-Phase Current Mode PWM Controller

The **ISL73847M** is a synchronous buck controller that can operate as a single or dual-phase controller. It works with the ISL71441M (half-bridge GaN FET driver) to generate point-of-load voltage rails for commercial space applications.

Supporting an input voltage range of 4.5V to 19V, the ISL73847M offers a programmable PWM switching frequency from 250kHz to 1.5MHz, adjustable with a single resistor. The output voltage is configurable above 600mV, with the upper limit determined by the minimum off-time and selected switching frequency.

The ISL73847M features built-in current sharing, enabling two-phase operation within a single device and four-phase operation using two ISL73847M devices, all without requiring an external clock at  $\leq 1.04\text{MHz}$ . For multi-phase operation at other frequencies, the ISL74420 provides additional scalability, making it a flexible solution for multi-phase power architectures.

Its wide input voltage range makes it ideal for high-current FPGA core power and general-purpose power applications. The current mode modulation architecture simplifies loop compensation, enhances power supply rejection, and supports remote sensing to compensate for voltage drops under load. These features deliver a high-density, robust power solution that minimizes external components while ensuring efficient and reliable performance.

The ISL73847M operates across the military temperature range from  $-55^\circ\text{C}$  to  $+125^\circ\text{C}$  and is available in a 24 Ld WSOIC plastic package.

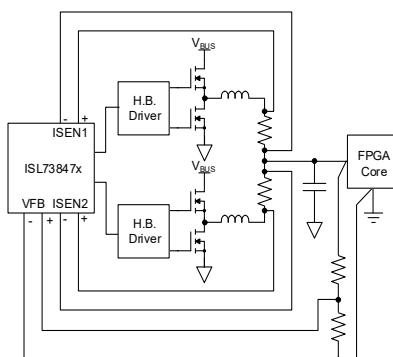


Figure 1. FPGA Core Power Supply Application

## Features

- Qualified to Renesas Rad Tolerant Screening and QCI Flow ([R34TB0004EU](#))
- Wide operating voltage range:
  - Input: 4.5V to 19V
  - Output:  $0.6\text{V}$  to  $V_{\text{PWR\_STAGE}} \times ((T_{\text{sw}} - 120\text{ns}) / T_{\text{sw}})$
- Programmable PWM output switching frequency
  - 250kHz to 1.5MHz
- Optional Droop regulation
- Current mode control provides
  - Excellent power supply rejection
  - Simplified control scheme
- Output differential remote sensing
- Programmable soft-start
- Enable control
- Power-good Indicator
- TID radiation lot acceptance testing (LDR:  $\leq 0.01\text{rad(Si)/s}$ )
  - ISL73847M30BZ: 30krad(Si)
  - ISL73847M50BZ: 50krad(Si)
- SEE characterization
  - No DSEE with  $V_{\text{DD}} = 25\text{V}$  and  $43\text{MeV}\cdot\text{cm}^2/\text{mg}$
  - SEFI  $< 3\mu\text{m}^2$  at  $43\text{MeV}\cdot\text{cm}^2/\text{mg}$
  - SET  $< 2\%$  on  $V_{\text{OUT}}$  at  $43\text{MeV}\cdot\text{cm}^2/\text{mg}$

## Applications

- FPGA Core Power Supply
- General Purpose Power Supply

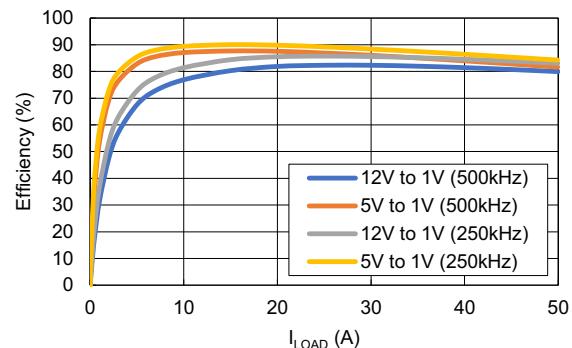


Figure 2. 12V to 1V and 5V to 1V Conversion Efficiency

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# 1. Overview

## 1.1 Typical Application Diagrams

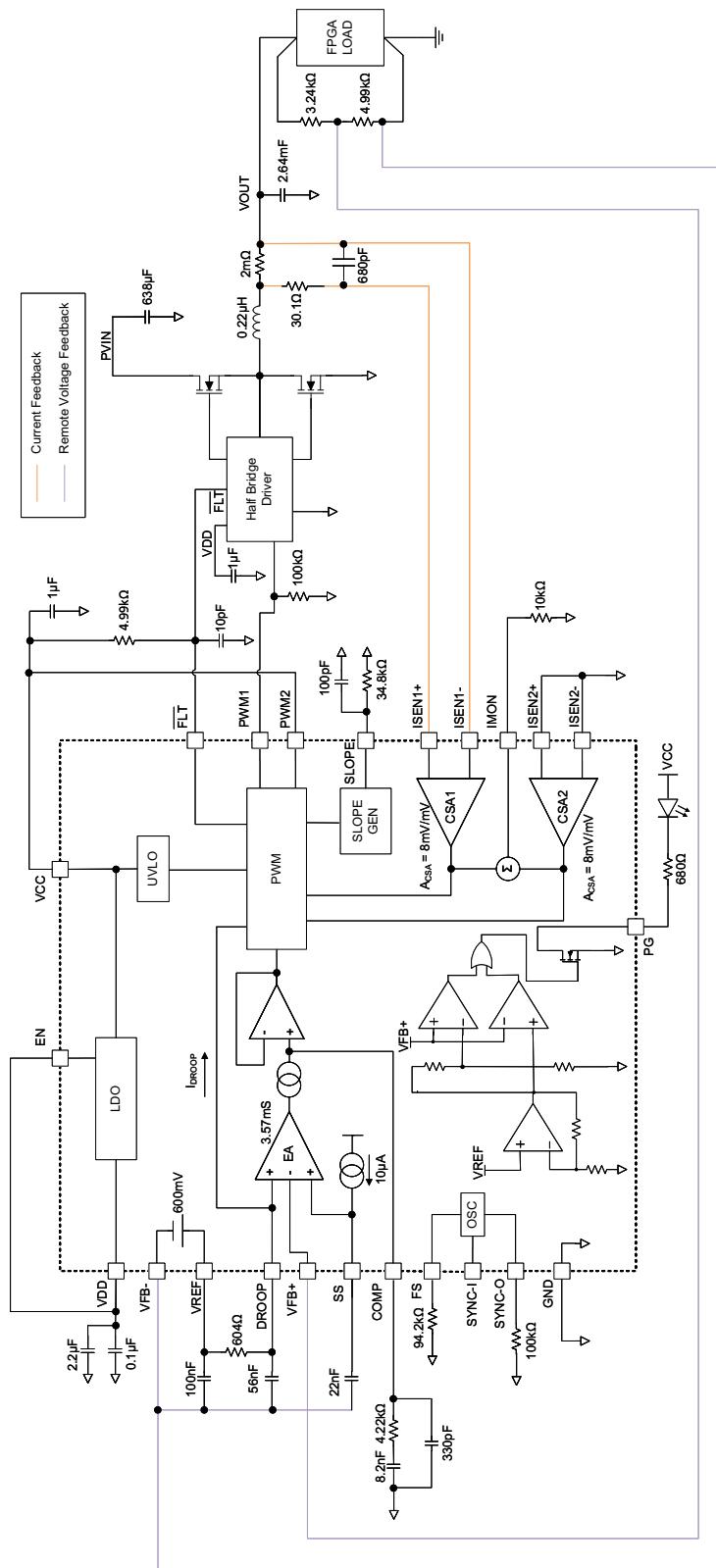


Figure 3. Typical Application (Single Phase) using One ISL71441M Half-Bridge Driver

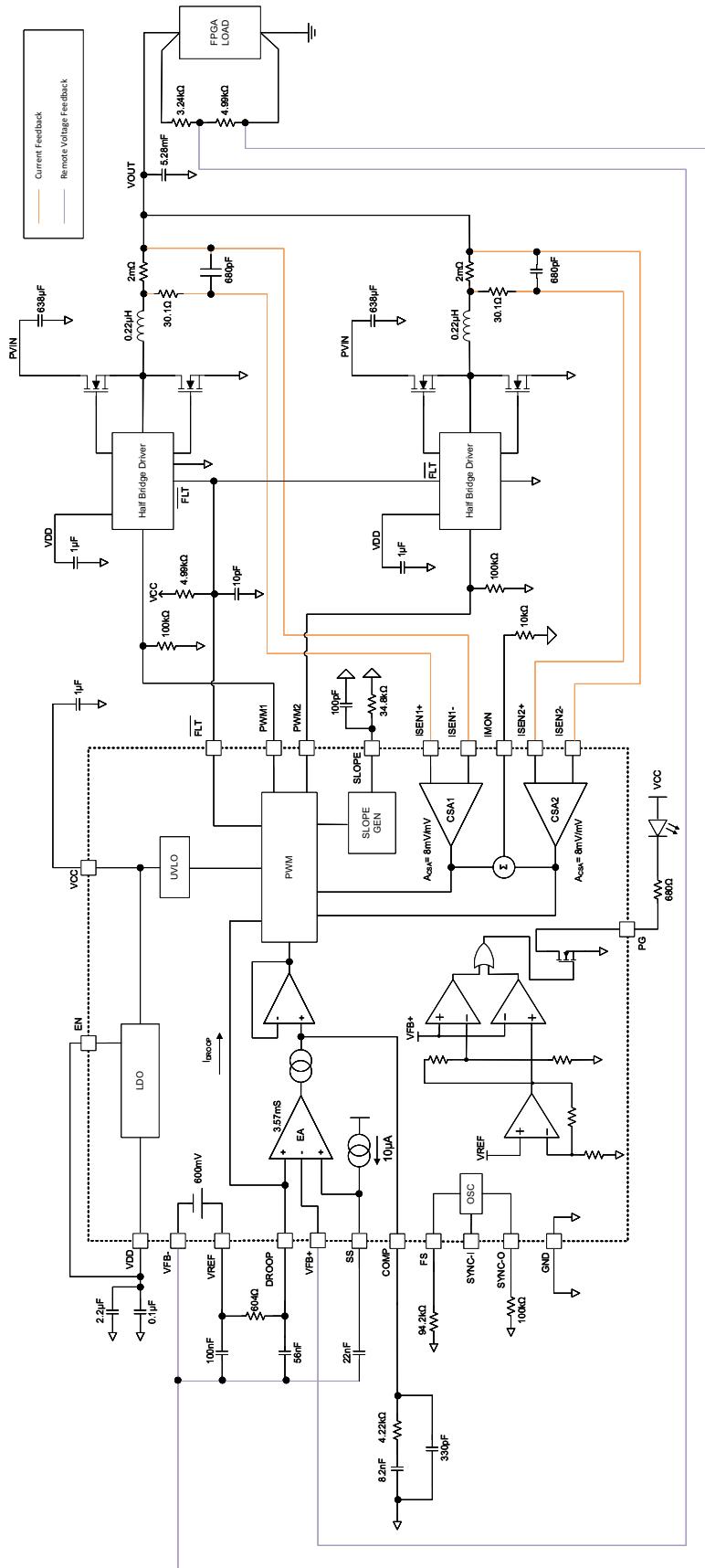


Figure 4. Typical Application (Dual-Phase) using Two ISL71441M Half-Bridge Drivers

## 1.2 Functional Block Diagram

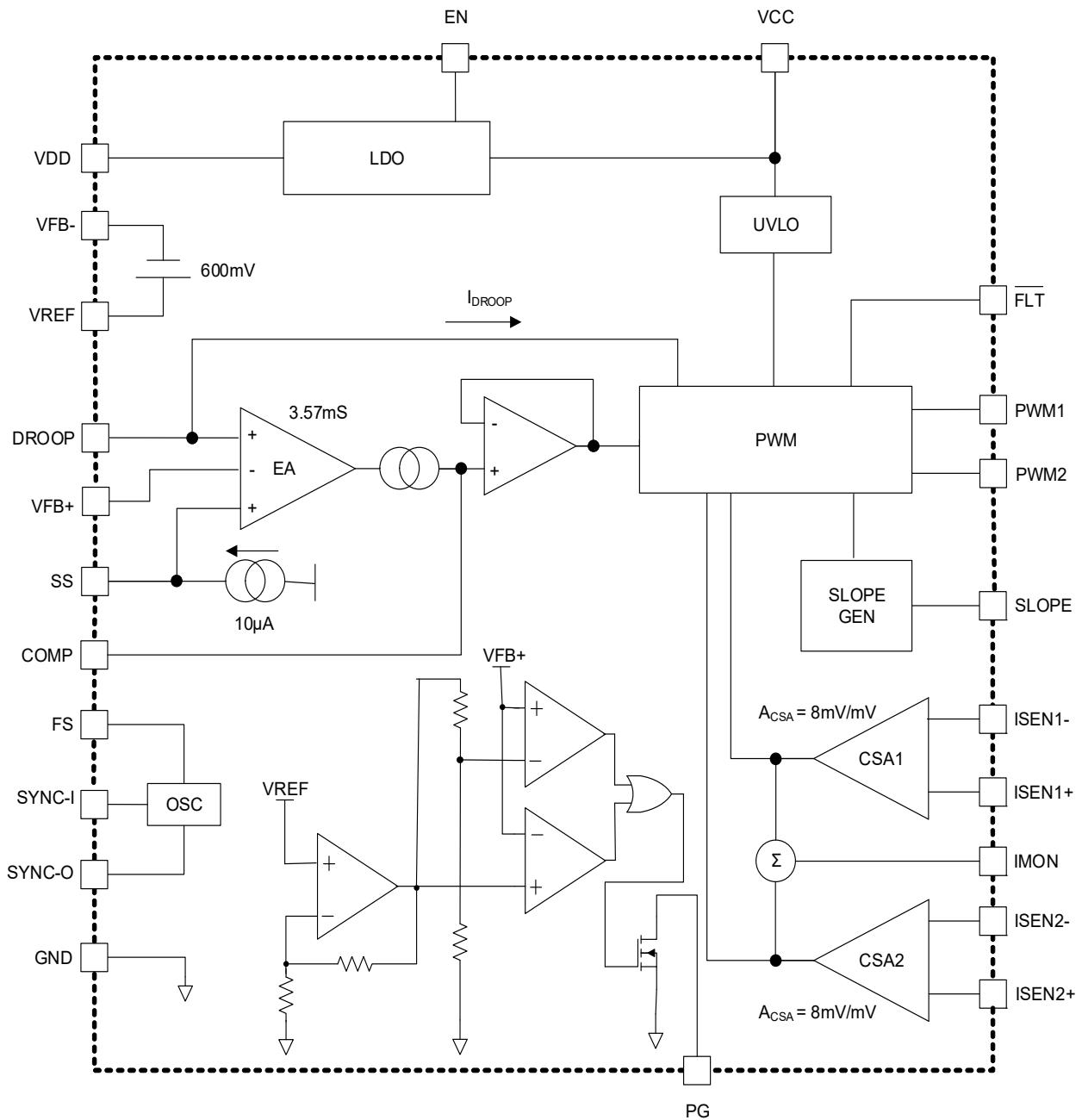


Figure 5. Block Diagram

## 2. Pin Information

### 2.1 Pin Assignments

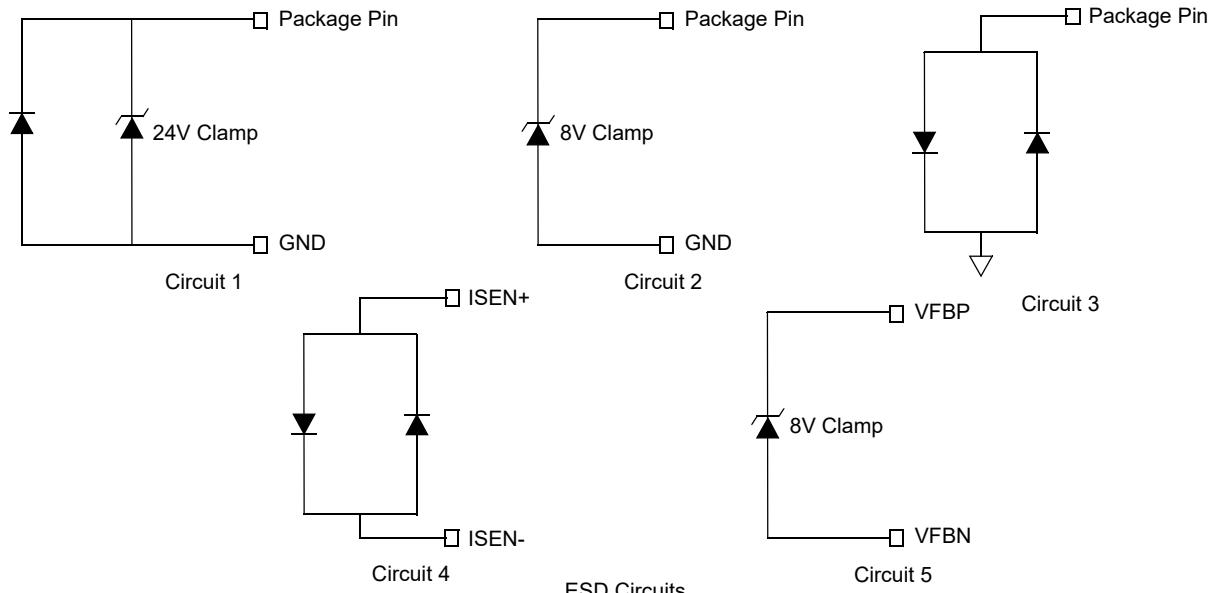
VDD	1	24	PWM1
SYNC-I	2	23	EN
SYNC-O	3	22	ISEN1+
VCC	4	21	ISEN1-
VCC	5	20	GND
FS	6	19	SLOPE
SS	7	18	FLT
COMP	8	17	IMON
VREF	9	16	ISEN2-
DROOP	10	15	ISEN2+
VFB-	11	14	PG
VFB+	12	13	PWM2

Figure 6. Pin Assignments - 24 Ld WSOIC Top View

### 2.2 Pin Descriptions

Pin Number	Pin Name	ESD Circuit	Description
1	VDD	1	The power supply input to the IC. The voltage range on this pin is 4.5V to 19V. Connect a 2.2 $\mu$ F or larger capacitor and a 100nF capacitor from the VDD pin to GND.
2	SYNC-I	2	This pin is an input that accepts 2x the required PWM output switching frequency (regardless of single or dual phase). Internally the IC divides the clock down to get two clocks 180° from each other for each phase. <i>Note:</i> This pin has an internal pull down, leave it floating if SYNC function is not needed.
3	SYNC-O	2	This pin can output either 1x or 2x the PWM output switching frequency depending on the loading present on the pin during power up (before soft-start). When outputting 1x, the SYNC-O is 180° out of phase with phase 1 clock. The 2x SYNC-O output is in phase with the SYNC-I. 100k $\Omega$ to VCC: SYNC-O outputs 1x PWM output switching frequency. 100k $\Omega$ to GND: SYNC-O outputs 2x PWM output switching frequency.
4, 5	VCC	2	Output of internal LDO for analog circuitry. Short pins 4 and 5 together. Connect a 1 $\mu$ F ceramic capacitor from VCC to GND.
6	FS	2	This pin sets the frequency for the internal oscillator between 0.5MHz and 3MHz. This sets the output between 0.25 MHz and 1.5MHz for each phase. When FS is tied to VCC the internal oscillator frequency ( $f_{OSC}$ ) is 1MHz. To adjust the internal oscillator frequency between 0.5MHz and 3MHz (0.25MHz to 1.5MHz PWM switching frequency), use a resistor between FS and GND. If SYNC-I is being used to sync to an external clock, FS needs to be set such that the internal oscillator frequency is 15% less than the external frequency. Use <a href="#">Equation 3</a> to find which resistor is needed for a given frequency.
7	SS	2	This is the soft-start pin. Connect a ceramic capacitor from SS to GND to set the soft-start ramp. The soft-start time is adjustable between 2ms and 200ms. <a href="#">Equation 24</a> shows the relationship between the soft-start capacitor and soft-start time.
8	COMP	2	The output of the error amplifier. Connect a resistor and capacitor in series to ground for type 2 compensation adjustment. For type-3 compensation, add an additional capacitor in parallel with the type-2 series RC components.

Pin Number	Pin Name	ESD Circuit	Description
9	VREF	2	The output of the internal voltage reference. Insert a resistor between VREF and DROOP to enable droop regulation. Short VREF and DROOP pin together to disable droop regulation.
10	DROOP	2	This pin is a current mirrored version of the output of the current sense amp output (sum of both phases). This output can be tied to the VREF pin through a resistor to enable droop regulation. The voltage created by the mirrored current and the resistor between VREF and DROOP sets the droop level.
11	VFB-	3	This pin is the negative input for differential voltage feedback.
12	VFB+	5	This pin is the positive input for differential voltage feedback.
13	PWM2	2	This pin is the PWM output for the secondary phase. This pin needs a 100kΩ to GND.
14	PG	1	This pin is the power good indicator. It is an open-drain output. Limit the sink current through this pin to below 7.2mA.
15	ISEN2+	4	This pin is the positive input for the secondary phase current sense amplifier.
16	ISEN2-	1	This pin is the negative input for the secondary phase current sense amplifier.
17	IMON	2	This pin outputs the summed average of the current sense amplifiers outputs for telemetry purposes.
18	FLT	2	This pin sequences the startup between the ISL73847M and compatible drivers. On the ISL73847M, this pin operates as a bi-directional I/O during power up (before soft-start) and as an input while switching (during and after soft-start). This pin's input threshold voltage is $V_{FLTMID}$ . A logic low on this pin indicates that either the ISL73847M or compatible driver has encountered a fault or is not ready to start switching. A logic high indicates that there are not faults for either device. Because FLT is an open-drain output, use a 4.99kΩ typical pull-up resistor to VCC for a proper high level.
19	SLOPE	2	This pin adjusts the slope compensation of the ISL73847M. Place a resistor in the range of 25kΩ to 100kΩ to adjust slope compensation.
20	GND	N/A	This is the ground reference for the ISL73847M.
21	ISEN1-	1	This pin is the negative input for the primary phase current sense amplifier.
22	ISEN1+	4	This pin is the positive input for the primary phase current sense amplifier.
23	EN	1	This pin is the chip enable for the ISL73847M.
24	PWM1	2	This pin is the PWM output for the primary phase. This pin needs a 100kΩ to GND.



### 3. Specifications

#### 3.1 Absolute Maximum Ratings

**Caution:** Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

Parameter	Minimum	Maximum	Unit
VDD, ISENsx, EN, PG	GND - 0.3	GND + 20	V
ISENSx <sup>[1][2]</sup>	GND - 0.3	GND + 12	V
VCC	GND - 0.3	6.5	V
VCC <sup>[1]</sup>	GND - 0.3	6.5	V
VREF, DROOP, VFBx, FS, COMP, SLOPE, $\overline{FLT}$ , IMON	GND - 0.3	VCC + 0.3	V
PWMx, SYNC-I, SYNC-O	GND - 0.3	VCC + 0.3	V
Differential Voltage Across Current Sense Inputs V(ISENx+) - V(ISENx-) <sup>[3]</sup>	-0.3	+0.3	V
Maximum Junction Temperature	-	+150	°C
Maximum Storage Temperature Range	-65	+150	°C
Human Body Model (Tested per MIL-STD-883 TM3015.7)	-	2	kV
Charged Device Model (Tested per JS-002-2022)	-	750	V
Latch-Up (Tested per JESD78E; Class 2, Level A)	-	±100	mA

1. Tested under a heavy ion environment.
2. No SEFI seen  $\leq 10V$  at LET  $43\text{MeV}\cdot\text{cm}^2/\text{mg}$ .
3. Maximum current through anti-parallel diodes should be  $\leq 10\text{mA}$ .

#### 3.2 Recommended Operating Conditions

Parameter	Minimum	Maximum	Unit
VDD, EN, PG	GND + 4.5	GND + 19.0	V
ISENx Common Mode Range	GND - 0.3	19	V
Differential Voltage Across Current Sense Inputs V(ISENx+) - V(ISENx-)	-75	100	mV
PWM Output Switching Frequency	0.25	1.5	MHz
Regulated Output Voltage	0.6	$\text{PVIN} \times ((T_{SW} - 120\text{ns})/T_{SW})$	V
Ambient Temperature	-55	125	°C

### 3.3 Outgas Testing

Specification (Tested per ASTM E595, 1.5)	Value	Unit
Total Mass Loss <sup>[1]</sup>	0.05	%
Collected Volatile Condensable Material <sup>[1]</sup>	0.01	%
Water Vapor Recovered	0.01	%

1. Outgassing results meet NASA requirements of total mass loss <1% and collected volatile condensable material <0.1%.

### 3.4 Thermal Specifications

Parameter	Package	Symbol	Conditions	Typical Value	Unit
Thermal Resistance	24 Ld WSOIC	$\theta_{JA}^{[1]}$	Junction to ambient.	39	°C/W
		$\theta_{JC}^{[2]}$	Junction to case.	14	

1.  $\theta_{JA}$  is measured in free air with the component mounted on a high-effective thermal conductivity test board. See [TB379](#).

2. For  $\theta_{JC}$ , the case temperature location is the center of the package top surface.

### 3.5 Electrical Specifications

$V_{DD} = 4.5V$  &  $19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of  $30\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of  $50\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only).

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>Input Power Supply</b>						
Supply Voltage Range	$V_{DD}$	-	<b>4.5</b>		<b>19</b>	V
Rising $V_{DD}$ UVLO	$V_{DDUV(R)}$	$EN = V_{DD}$	<b>4.05</b>	4.2	<b>4.4</b>	V
Falling $V_{DD}$ UVLO	$V_{DDUV(F)}$	$EN = V_{DD}$	<b>3.85</b>	4.0	<b>4.1</b>	V
$V_{DD}$ UVLO Hysteresis	$V_{DDUV(HYS)}$	$EN = V_{DD}$	<b>150</b>	220	<b>300</b>	mV
Operating Supply Current	$I_{DDO}$	$V_{DD} = 4.5V, 12V, 19V$ $EN = 3.3V, f_{SW} = 500\text{kHz}, C_L = 100\text{pF}$	<b>9</b>	12	<b>16</b>	mA
Shutdown Supply Current	$I_{DDSD}$	$V_{DD} = 4.5V, 12V, 19V, EN = GND$	-	11	<b>35</b>	$\mu A$
<b>Internal LDO</b>						
Output Range	$V_{CC}$	$V_{DD} = 6.0V, 19V$ $I_{OUT} = 0\text{mA}, 20\text{mA}$	<b>4.7</b>	5.0	<b>5.3</b>	V
Dropout Voltage	$V_{CCDO}$	$V_{DD} = 4.5V, I_{OUT} = 50\text{mA}$	<b>85</b>	160	<b>250</b>	mV
Rising $V_{CC}$ UVLO	$V_{CCUV(R)}$	$EN = V_{DD}$	<b>3.4</b>	3.6	<b>3.7</b>	V
Falling $V_{CC}$ UVLO	$V_{CCUV(F)}$	$EN = V_{DD}$	<b>3.2</b>	3.3	<b>3.5</b>	V
$V_{CC}$ UVLO Hysteresis	$V_{CCUV(HYS)}$	$EN = V_{DD}$	<b>150</b>	210	<b>300</b>	mV
$V_{CC}$ Foldback Current	$I_{CC-SC}$	$V_{DD} = 19V, V_{CC} = 0V, EN = 1.6V$	<b>40</b>	72	<b>90</b>	mA
$V_{CC}$ Overcurrent Limit	$I_{CC-CL}$	$V_{DD} = 19V, V_{CC} = 4.3V, EN = 1.6V$	<b>75</b>	98	<b>130</b>	mA

$V_{DD} = 4.5V \& 19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of 30krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of 50krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only). (Cont.)

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>Output Regulation</b>						
Set Point Voltage <sup>[2]</sup>	$V_{FB+}$	$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}, 50\text{mV}, T_A = -55^\circ C$	0.592	0.597	0.601	V
		$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}, 50\text{mV}, T_A = +25^\circ C$	0.598	0.600	0.602	
		$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}, 50\text{mV}, T_A = +125^\circ C$	0.594	0.600	0.607	
		$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}, 50\text{mV}, T_A = +25^\circ C$ (Post Rad)	0.592	0.600	0.604	
Set Point Accuracy Over Line Delta <sup>[2][3]</sup>	$V_{FB+}$	$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}$	<b>-1.2</b>	0.2	<b>0.8</b>	mV
Set Point Accuracy Over Load Delta <sup>[2][3]</sup>	$V_{FB+}$	$V_{REF} = V_{DROOP}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}, 50\text{mV}$	<b>-1.0</b>	0.05	<b>1.0</b>	mV
FB+ Input Bias Current	$I_{FB+BIAS}$	$V(FB+) = 0.6V$	<b>-50</b>	-0.25	<b>50</b>	nA
FB- Input Bias Current	$I_{FB-BIAS}$	$V(FB-) = 0V, EN > V_{IH-EN-G}$ $V_{SEN1} = V_{SEN2} = 0\text{mV}$	<b>30</b>	121	<b>350</b>	μA
Soft-Start Sourcing Current	$I_{SOFTSTART}$	-	<b>9.2</b>	10	<b>10.5</b>	μA
Soft-Start Pull-Down Resistance	$R_{SS-PULLDN}$	EN = 0V	<b>4</b>	11	<b>18</b>	Ω
<b>Protection Features</b>						
Peak Positive Current Limit Threshold	$V_{PCL}$	$V_{CM} = 0.6V, 5.0V, 19V$	<b>67.5</b>	75	<b>82.5</b>	mV
Peak Positive Overcurrent Threshold	$V_{POC}$	$V_{CM} = 0.6V, 5.0V, 19V$	<b>90</b>	100	<b>110</b>	mV
Peak Negative Overcurrent Threshold	$V_{NOC}$	$V_{CM} = 0.6V, 5.0V, 19V$	<b>-84</b>	-71	<b>-60</b>	mV
Overvoltage Threshold	$V_{(FB, OV)}$	$V_{DD} = 4.5V$ and $19V$	<b>112</b>	115	<b>118</b>	%
Undervoltage Threshold	$V_{(FB, UV)}$	$V_{DD} = 4.5V$ and $19V$	<b>82</b>	85	<b>88</b>	%
FLT Drive current	$I_{FLT}$	$V_{DD} = 4.5V$ and $19V$ , $\overline{FLT} = 400\text{mV}$	<b>20</b>	50	<b>75</b>	mA
FLT Mid Threshold Voltage	$V_{FLT MID}$	$V_{DD} = 4.5V$ and $19V$	<b>1.6</b>	2.08	<b>2.55</b>	V
FLT Leakage Current	$I_{FLTLKG}$	$\overline{FLT} = 4.5V$ when $V_{DD} = 4.5V$ $\overline{FLT} = 5V$ when $V_{DD} = 19V$	<b>-2</b>	0.07	<b>2</b>	μA
<b>Error Amplifier</b>						
Transconductance	9m-EA	$T_A = -55^\circ C$	3	4.1	4.5	mA/V
		$T_A = +25^\circ C$	3	3.57	4	
		$T_A = +125^\circ C$	2.5	3.04	3.5	
		$T_A = +25^\circ C$ (Post Rad)	3	3.6	4	

$V_{DD} = 4.5V \& 19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of 30krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of 50krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only). (Cont.)

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
DC Gain	$A_{V-EA}$	-	66	80	-	dB
Gain-Bandwidth Product	$GBW_{EA}$	-	15	-	-	MHz
Output Voltage Range	$V_{COMP(RNG)}$	$V_{DD} = 4.5V$	<b>0.4</b>	-	<b>4.1</b>	V
		$V_{DD} = 19V$	<b>0.4</b>	-	<b>4.6</b>	
Output Slew Rate	$SR_{EA}$	-	-	8.5	-	V/ $\mu$ s
<b>Current-Sense Amplifier</b>						
Droop Transconductance	$g_m(\text{CSA, DRP})$	$V(I_{SEN+}, I_{SEN-}) = 10\text{mV, 50mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = -55^\circ C$	0.38	0.4	0.42	$\mu\text{A/mV}$
		$V(I_{SEN+}, I_{SEN-}) = 10\text{mV, 50mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$	0.38	0.4	0.42	
		$V(I_{SEN+}, I_{SEN-}) = 10\text{mV, 50mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +125^\circ C$	0.375	0.39	0.41	
		$V(I_{SEN+}, I_{SEN-}) = 10\text{mV, 50mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$ (Post Rad)	0.38	0.4	0.42	
Droop Current	$I_{DROOP}$	$V(I_{SEN+}, I_{SEN-}) = 50\text{mV, } V_{CM} = 0.6V, 5.0V, 19V, T_A = -55^\circ C$	16	18.7	24	$\mu\text{A}$
		$V(I_{SEN+}, I_{SEN-}) = 50\text{mV, } V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$	18.2	19.9	21.8	
		$V(I_{SEN+}, I_{SEN-}) = 50\text{mV, } V_{CM} = 0.6V, 5.0V, 19V, T_A = +125^\circ C$	16	20.5	24	
		$V(I_{SEN+}, I_{SEN-}) = 50\text{mV, } V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$ (Post Rad)	16	19.7	24	
IMON Transconductance	$g_m(\text{CSA, IMON})$	$V(I_{SEN+}, I_{SEN-}) = 10\text{mV, 50mV}$ $V_{CM} = 0.6V, 5.0V, 19V$	<b>0.36</b>	0.39	<b>0.47</b>	$\mu\text{A/mV}$
Gain from CSA input to PWM Comparator input	$A_{\text{CSA-PWM}}$	$V(I_{SEN+}, I_{SEN-}) = 50\text{mV}$	<b>7.5</b>	8	<b>8.5</b>	$\text{mV/mV}$
Offset Voltage	$V_{OS(\text{CSA})}$	$V(I_{SEN+} - I_{SEN-}) = 0\text{mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = -55^\circ C$	-5.5	-0.2	5.5	$\text{mV}$
		$V(I_{SEN+} - I_{SEN-}) = 0\text{mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$	-2	-0.05	2	
		$V(I_{SEN+} - I_{SEN-}) = 0\text{mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +125^\circ C$	-7	0.15	7	
		$V(I_{SEN+} - I_{SEN-}) = 0\text{mV}$ $V_{CM} = 0.6V, 5.0V, 19V, T_A = +25^\circ C$ (Post Rad)	-5	-0.13	5	
Positive Input Leakage Current	$I_{LKG+}(\text{CSA})$	$EN = 0V, V_{CM} = 0.6V, 5.0V, 19V$	<b>-50</b>	4	<b>50</b>	nA
Negative Input Leakage Current	$I_{LKG-}(\text{CSA})$	$EN = 0V, V_{CM} = 0.6V$	-	1.55	<b>200</b>	nA
		$EN = 0V, V_{CM} = 5.0V, 19V$	-	0.325	<b>1.0</b>	$\mu\text{A}$

$V_{DD} = 4.5V \& 19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of 30krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of 50krad(Si) at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only). (Cont.)

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
HS CSA Supply Current per Phase (Current into ISENx-pin)	$I_{CSA}$	$EN = 3.3V, V_{CM} = 2.7V$	-	2	3	$\mu A$
Transition from Low Side to High Side	$V_{CS(TRAN)}$	$V_{DD} = 4.5V$	<b>1.95</b>	2.13	<b>2.35</b>	V
Transition from Low Side to High Side	$V_{CS(TRAN)}$	$V_{DD} = 19V$	<b>2.25</b>	2.37	<b>2.5</b>	V
Gain-Bandwidth Product	$GBW_{CSA}$	-	<b>10</b>	-	-	MHz
<b>Oscillator/Slope Generator</b>						
Default Oscillator Frequency	$f_{OSC-D}$	$FS = V_{CC}, V_{DD} = 4.5V, 19V$	<b>0.90</b>	1.00	<b>1.10</b>	MHz
Oscillator Frequency Range	$f_{OSC-0.5M}$	$R_{FS} = 205k\Omega, EN = 3.3V, R_{SYNC-O} = 100k\Omega$ to GND	<b>0.45</b>	0.5	<b>0.55</b>	MHz
	$f_{OSC-1M}$	$R_{FS} = 94.2k\Omega, EN = 3.3V, R_{SYNC-O} = 100k\Omega$ to GND	<b>0.90</b>	1.00	<b>1.10</b>	
	$f_{OSC-2M}$	$R_{FS} = 37k\Omega, EN = 3.3V, R_{SYNC-O} = 100k\Omega$ to GND	<b>1.80</b>	2.00	<b>2.20</b>	
	$f_{OSC-3M}$	$R_{FS} = 16.7k\Omega, EN = 3.3V, R_{SYNC-O} = 100k\Omega$ to GND	<b>2.70</b>	3.00	<b>3.30</b>	
Slope Pin Current	$I_{SLOPE}$	$V_{SLOPE} = 400mV, V_{DD} = 4.5V, 19V$	<b>11.2</b>	12	<b>12.6</b>	$\mu A$
Default Slope Compensation Reference Voltage	$V_{SLOPE\_DFLT}$	-	<b>1.14</b>	1.2	<b>1.26</b>	V
Ramp Slope	$V_{RAMP-SLOPE}$	$f_{SW} = 500kHz, V_{SLOPE} = 0.4V$	<b>0.065</b>	0.098	<b>0.150</b>	V/ $\mu s$
<b>Enable</b>						
Rising Enable Threshold (Gross)	$V_{IH-EN-G}$	$FS = V_{CC}$	<b>0.9</b>	1.3	<b>1.6</b>	V
Falling Enable Threshold (Gross)	$V_{IL-EN-G}$	$FS = V_{CC}$	<b>0.6</b>	1.0	<b>1.2</b>	V
Enable Threshold Hysteresis (Gross)	$V_{HYS-EN-G}$	$FS = V_{CC}$	<b>200</b>	350	<b>500</b>	mV
Rising Enable Threshold (Fine)	$V_{IH-EN-F}$	$FS = V_{CC}$	<b>1.74</b>	1.8	<b>1.85</b>	V
Falling Enable Threshold (Fine)	$V_{IL-EN-F}$	$FS = V_{CC}$	<b>1.46</b>	1.5	<b>1.54</b>	V
Enable Threshold Hysteresis (Fine)	$V_{HYS-EN-F}$	$FS = V_{CC}$	<b>260</b>	295	<b>320</b>	mV
EN Rising to Boot Refresh Delay	$t_{EN}$	$FS = V_{CC}$	<b>1.9</b>	2.3	<b>2.8</b>	ms
Pull-Down Resistance	$R_{EN}$	$EN = 19V$	-	1	-	$M\Omega$
EN Leakage	$EN_{LK}$	$V_{DD} = EN = 19V$	<b>20</b>	120	<b>250</b>	nA

$V_{DD} = 4.5V$  &  $19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of  $30\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of  $50\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only). (Cont.)

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>Power-Good</b>						
Overvoltage Error Threshold	$V_{OVH}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>106</b>	108	<b>110</b>	%
Overvoltage Error Threshold Recovery	$V_{OVL}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>104</b>	106	<b>109</b>	%
Overvoltage Error Hysteresis	$V_{OVH}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>1.2</b>	2	<b>3.5</b>	%
Undervoltage Error Threshold	$V_{UVL}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>90</b>	92	<b>95</b>	%
Undervoltage Error Threshold Recovery	$V_{UVH}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>92</b>	94	<b>97</b>	%
Undervoltage Error Hysteresis	$V_{UVH}$	$EN = 3.3V$ , FB as a percent of $V_{REF}$	<b>1.25</b>	2.05	<b>3.5</b>	%
Sink Current	$I_{PG-SINK}$	$V_{DD} = 4.5V$ , $V(FB+, FB-) = V_{PG} = 0.4V$ , $EN = 0V$	<b>5</b>	18	<b>35</b>	mA
PG Leakage	$I_{PG-LKG}$	$V_{DD} = 4.5V$ , $V(FB+, FB-) = 0.6V$ , $V_{PG} = 19V$ , $EN = 0V$	-	0.02	<b>0.5</b>	$\mu A$
SS Voltage for PG to be Active After Power-Up	$V_{SS-PG}$	$V(SS) = 0V$ to $1V$ .	<b>0.82</b>	0.9	<b>0.98</b>	V
PG Reaction Time to OV Fault	$t_{PG-PROP-OV}$	$V(FB+, FB-) = 0.6V$ to $0.7V$	<b>12</b>	14.5	<b>18</b>	$\mu s$
PG Reaction time to UV Fault	$t_{PG-PROP-UV}$	$V(FB+, FB-) = 0.6V$ to $0.5V$	<b>12</b>	14.6	<b>18</b>	$\mu s$
Hiccup Retry Delay	$t_{HIC-DLY}$	$C_{SS} = 10nF$	<b>1.8</b>	2.7	<b>3.8</b>	ms
<b>PWM Outputs</b>						
PWM Output High	$V_{OH}$	$V_{DD} = 4.5V$ , $I_{PWM} = -500\mu A$	<b>4.0</b>	-	-	V
		$V_{DD} = 19V$ , $I_{PWM} = -500\mu A$	<b>4.5</b>	-	-	
PWM Output Mid	$V_{OZ}$	$I_{PWM} = \pm 100\mu A$	<b>1.8</b>	2.0	<b>2.3</b>	V
PWM Output Low	$V_{OL}$	$I_{PWM} = +500\mu A$	-	0.05	<b>0.4</b>	V
Turn-On Blanking Time	$t_{MINONBLK}$	-	<b>90</b>	99	<b>115</b>	ns
Turn-Off Blanking Time	$t_{MINOFFBLK}$	-	<b>100</b>	112	<b>130</b>	ns
Minimum Controllable ON-Time	$t_{MINCTRLON}$	-	<b>100</b>	115	<b>135</b>	ns
Minimum Controllable OFF-Time	$t_{MINCTRLOFF}$	-	<b>100</b>	116	<b>135</b>	ns
Passive Pull-Down	$R_{PWM-PLDN}$	-	-	5	-	$M\Omega$
Current Share between Phase 1 & 2 <sup>[4]</sup>	$I_{PHSHARE}$	$V_{CM} = 0.6V, 5V, 19V$ , $V(I_{SEN+}, I_{SEN-}) = 50mV$	-	8	-	%
Boot Refresh Repeat Timer	$t_{BOOT}$	-	<b>62</b>	68	<b>75</b>	$\mu s$

$V_{DD} = 4.5V$  &  $19V$ ,  $C_{VCC} = 1\mu F$  and  $T_A = +25^\circ C$ ; unless otherwise specified. **Boldface** limits apply across the operating temperature range,  $-55^\circ C$  to  $+125^\circ C$  by characterization with production testing at  $+25^\circ C$ ; over a total ionizing dose of  $30\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M30BZ only); or over a total ionizing dose of  $50\text{krad(Si)}$  at  $+25^\circ C$  with exposure at a low dose rate of  $<10\text{mrad(Si)/s}$  (ISL73847M50BZ only). (Cont.)

Parameter	Symbol	Test Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>SYNC</b>						
SYNC-I Input Voltage High	$V_{SYNCH}$	-	<b>1.7</b>	-	-	V
SYNC-I Input Voltage Low	$V_{SYNCL}$	-	-	-	<b>0.8</b>	V
SYNC-I Frequency (Referred to Internal Oscillator)	$f_{SYNCI}$	$FOSC = 500\text{kHz}$ , $R_{FS} = 205\text{k}\Omega$	<b>15</b>	-	-	%
SYNC-I Frequency (Referred to Internal Oscillator)	$f_{SYNCI}$	$FOSC = 2\text{MHz}$ , $R_{FS} = 37\text{k}\Omega$	<b>15</b>	-	-	%
SYNC-I Input Current	$I_{SYNC-IN}$	$V_{SYNC} = 5V$	<b>2.5</b>	5	<b>7.0</b>	$\mu A$
SYNC-I Pull-Down Resistance	$R_{SYNC-PULLDN}$	$V_{SYNC} = 5V$	-	1	-	$M\Omega$
SYNC-O Output Voltage High	$V_{SYNC-OH}$	$V_{DD} = 4.5V$ , $I_{SYNC-O} = -500\mu A$	<b>4.2</b>	-	-	V
		$V_{DD} = 19V$ , $I_{SYNC-O} = -500\mu A$	<b>4.6</b>	-	-	
SYNC-O Output Voltage Low	$V_{SYNC-OL}$	$I_{SYNC-O} = +500\mu A$	-	-	<b>0.4</b>	V
SYNC-I to PWM2 Delay	$t_{SYNC-I-DEL}$	-	-	260	-	ns
SYNC-O to PWM2 Delay	$t_{SYNC-O-DEL}$	-	-	20	-	ns
SYNC-I to SYNC-O Delay	$t_{SYNC-DLY}$	50% of SYNC-I to 50% of SYNC-O	<b>215</b>	240	<b>275</b>	ns
SYNC-O to PWM1 Phase Shift	$t_{SYNC-O-PWM1}$	Phase shift from PWM1	<b>178</b>	180	<b>184</b>	°
PWM1 to PWM2 Phase Shift	$t_{PWM1-PWM2}$	Phase shift from PWM1 to PWM2	<b>174</b>	180	<b>186</b>	°

1. Typical values are at  $25^\circ C$  and are not guaranteed.
2. This test is conducted in a closed loop circuit as shown in [Figure 7](#) and includes the error amplifier offset.
3. This specification is included within the Set Point Voltage specification.
4. Limits established by characterization and/or design analysis and are not production tested.

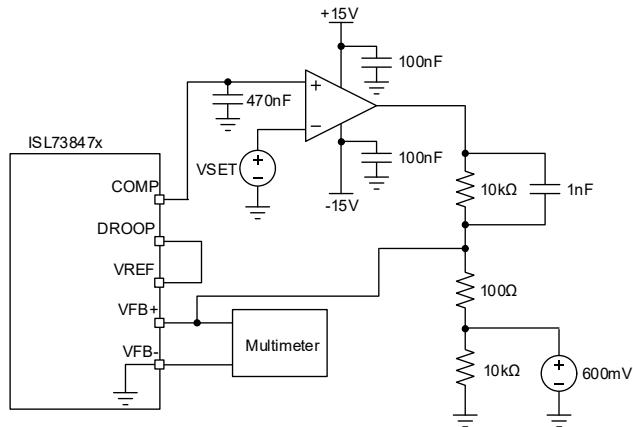


Figure 7. Closed-Loop Circuit

## 4. Typical Performance Curves

Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220nH$  per phase,  $C_{OUT} = 2.64mF$  per phase,  $C_{DROOP} = 56nF$ ,  $C_{VREF} = 100nF$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2k\Omega$ ,  $C_{SS} = 22nF$ ,  $C_{COMP} = 8.2nF$ ,  $R_{COMP} = 4.22k\Omega$ ,  $C_{POLE} = 330pF$ ,  $C_{VCC} = 1\mu F$ ,  $R_{SLP} = 34.8k\Omega$ ,  $C_{SLP} = 100pF$ ,  $T_A = +25^\circ C$

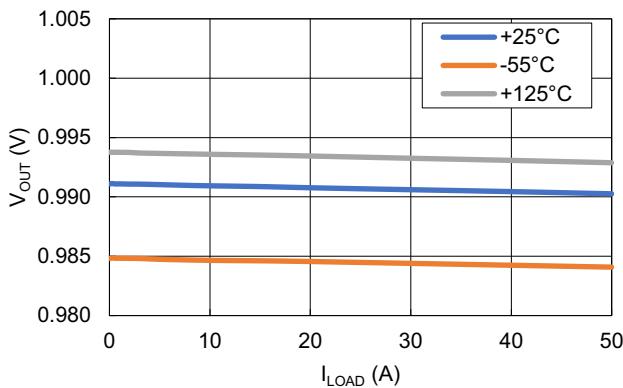


Figure 8. Load Regulation for Various Temperatures  
( $V_{IN} = 5V$ )

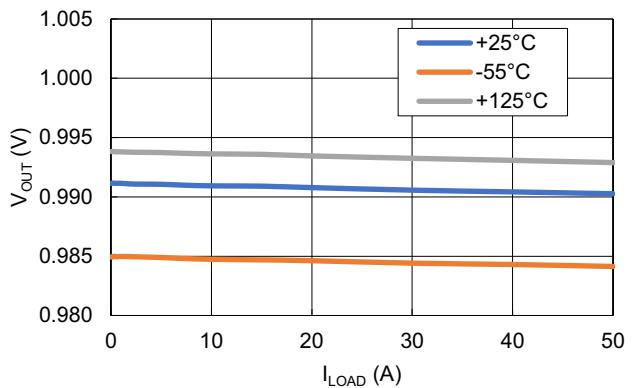


Figure 9. Load Regulation for Various Temperatures  
( $V_{IN} = 12V$ )

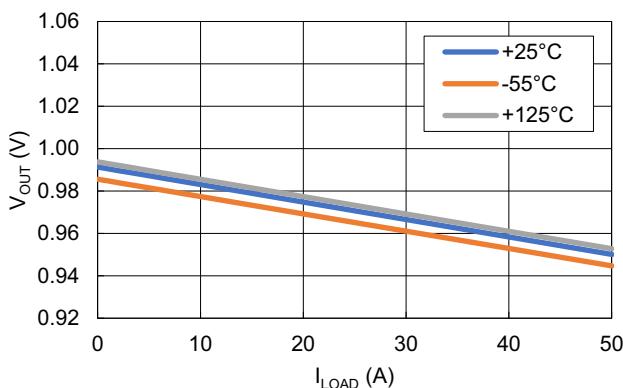


Figure 10. Droop Regulation for Various Temperatures  
( $V_{IN} = 5V$ ,  $R_{DROOP} = 604\Omega$ )

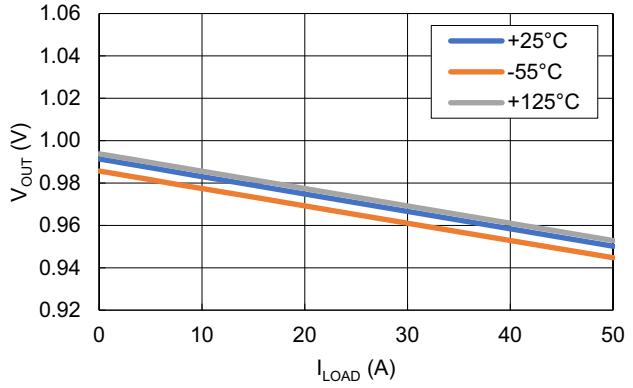


Figure 11. Droop Regulation for Various Temperatures  
( $V_{IN} = 12V$ ,  $R_{DROOP} = 604\Omega$ )

Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220\text{nH}$  per phase,  $C_{OUT} = 2.64\text{mF}$  per phase,  $C_{DROOP} = 56\text{nF}$ ,  $C_{VREF} = 100\text{nF}$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2\text{k}\Omega$ ,  $C_{SS} = 22\text{nF}$ ,  $C_{COMP} = 8.2\text{nF}$ ,  $R_{COMP} = 4.22\text{k}\Omega$ ,  $C_{POLE} = 330\text{pF}$ ,  $C_{VCC} = 1\mu\text{F}$ ,  $R_{SLP} = 34.8\text{k}\Omega$ ,  $C_{SLP} = 100\text{pF}$ ,  $T_A = +25^\circ\text{C}$  (Cont.)

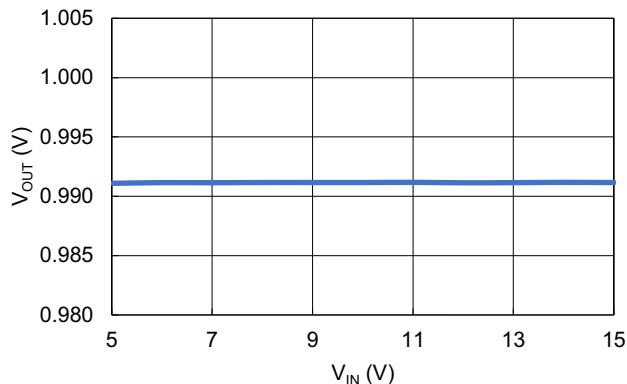


Figure 12. Line Regulation ( $I_{LOAD} = 0\text{A}$ )

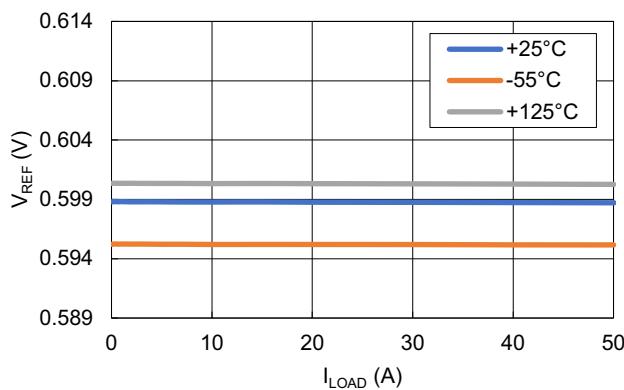


Figure 13.  $V_{REF}$  Accuracy for Various Temperatures  
( $V_{IN} = 5\text{V}$ )

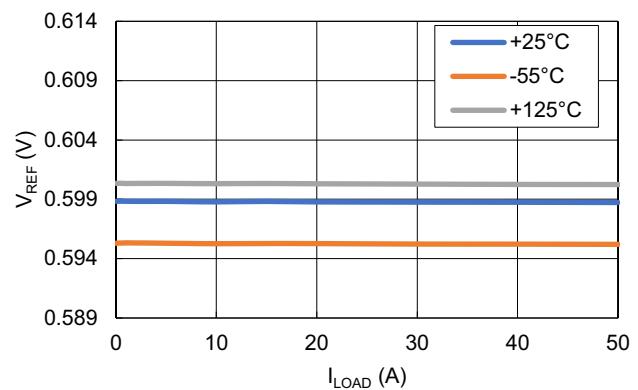


Figure 14.  $V_{REF}$  Accuracy for Various Temperatures  
( $V_{IN} = 12\text{V}$ )

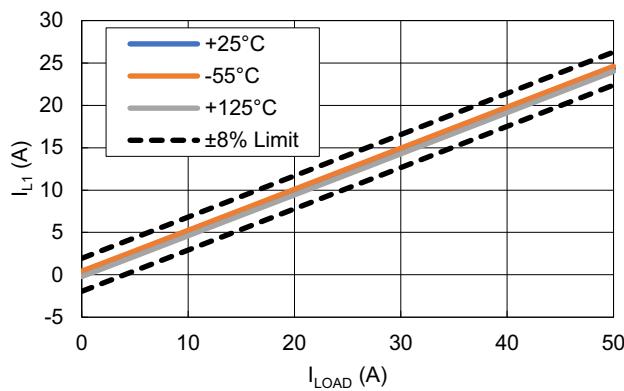


Figure 15. Phase 1 Current Share vs Temperature  
( $V_{IN} = 5\text{V}$ )

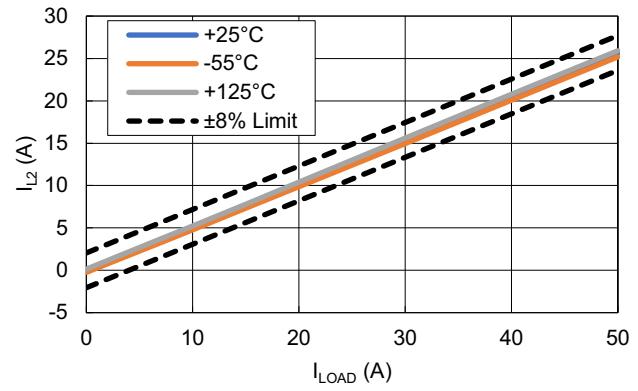
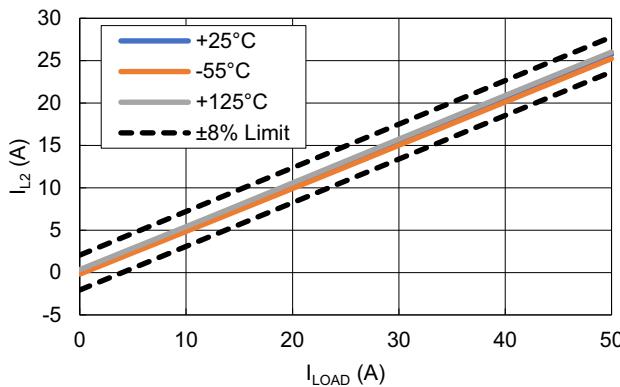
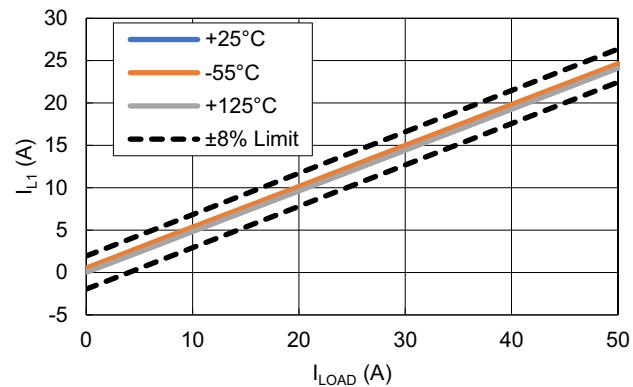


Figure 16. Phase 2 Current Share vs Temperature  
( $V_{IN} = 5\text{V}$ )

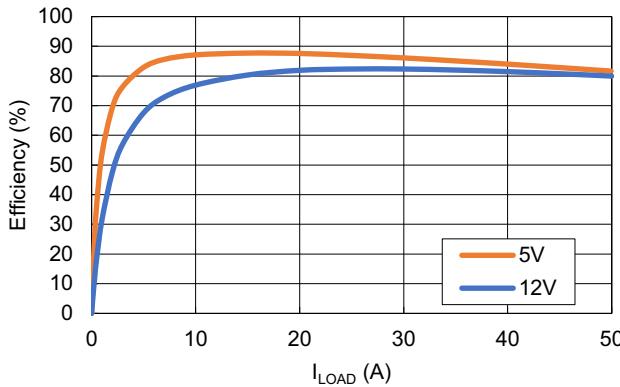
Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220\text{nH}$  per phase,  $C_{OUT} = 2.64\text{mF}$  per phase,  $C_{DROOP} = 56\text{nF}$ ,  $C_{VREF} = 100\text{nF}$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2\text{k}\Omega$ ,  $C_{SS} = 22\text{nF}$ ,  $C_{COMP} = 8.2\text{nF}$ ,  $R_{COMP} = 4.22\text{k}\Omega$ ,  $C_{POLE} = 330\text{pF}$ ,  $C_{VCC} = 1\mu\text{F}$ ,  $R_{SLP} = 34.8\text{k}\Omega$ ,  $C_{SLP} = 100\text{pF}$ ,  $T_A = +25^\circ\text{C}$  (Cont.)



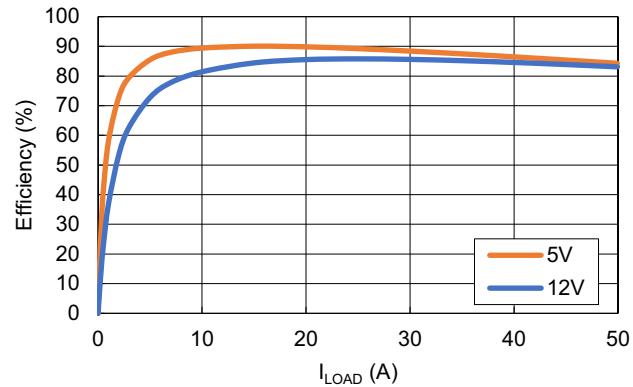
**Figure 17. Phase 1 Current Share vs Temperature  
( $V_{IN} = 12\text{V}$ )**



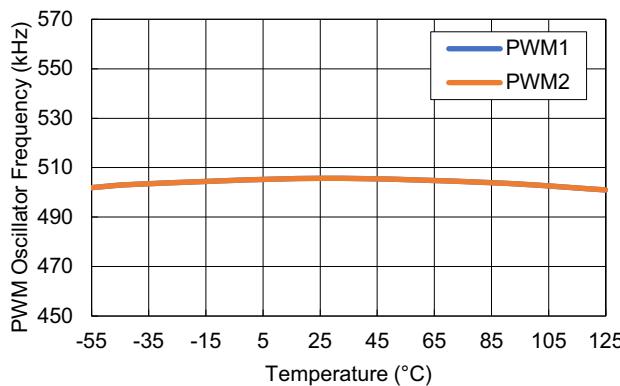
**Figure 18. Phase 2 Current Share vs Temperature  
( $V_{IN} = 12\text{V}$ )**



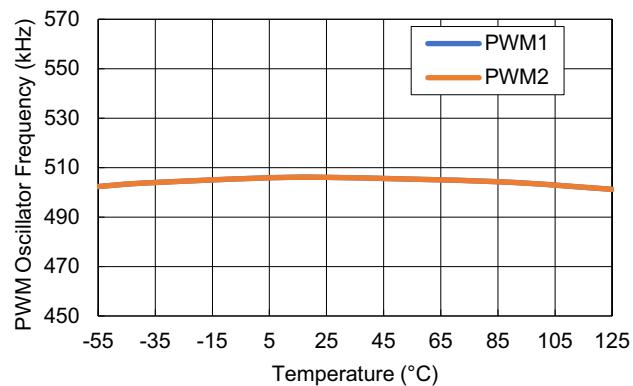
**Figure 19. Conversion Efficiency for Various  $V_{IN}$   
( $f_{sw} = 500\text{kHz}$ , Tested on the ISL73847MDEMO1Z)**



**Figure 20. Conversion Efficiency for Various  $V_{IN}$   
( $f_{sw} = 250\text{kHz}$ , Tested on the ISL73847MDEMO1Z),  
 $L_{OUT} = 450\text{nH}$  per phase,  $C_{OUT} = 5.28\text{mF}$  per phase,  
 $C_{COMP} = 15\text{nF}$ ,  $C_{DROOP} = 100\text{nF}$ ,  $R_{FS} = 205\text{k}\Omega$**

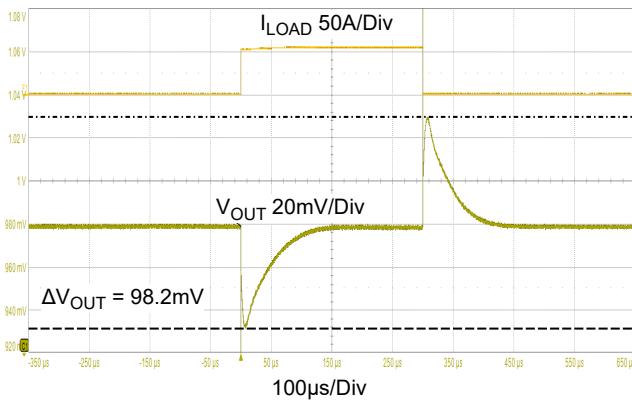


**Figure 21. PWMx Frequency vs Temperature ( $V_{IN} = 5\text{V}$ ,  
 $I_{LOAD} = 0\text{A}$ )**

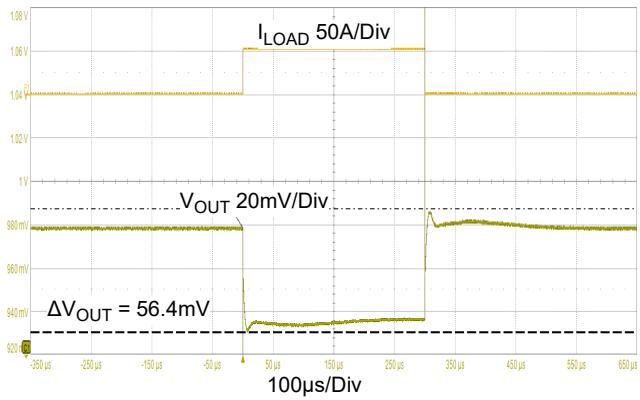


**Figure 22. PWMx Frequency vs Temperature ( $V_{IN} = 5\text{V}$ ,  
 $I_{LOAD} = 50\text{A}$ )**

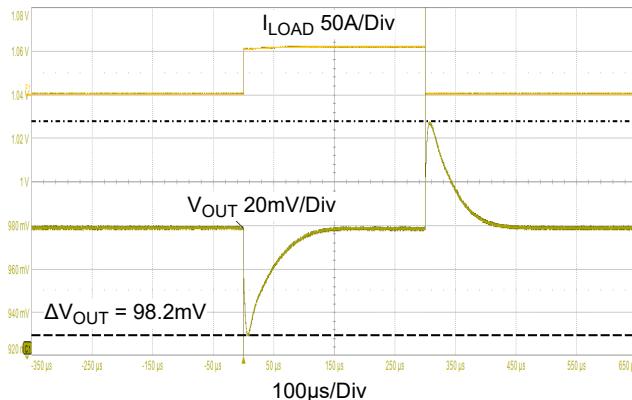
Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220\text{nH}$  per phase,  $C_{OUT} = 2.64\text{mF}$  per phase,  $C_{DROOP} = 56\text{nF}$ ,  $C_{VREF} = 100\text{nF}$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2\text{k}\Omega$ ,  $C_{SS} = 22\text{nF}$ ,  $C_{COMP} = 8.2\text{nF}$ ,  $R_{COMP} = 4.22\text{k}\Omega$ ,  $C_{POLE} = 330\text{pF}$ ,  $C_{VCC} = 1\mu\text{F}$ ,  $R_{SLP} = 34.8\text{k}\Omega$ ,  $C_{SLP} = 100\text{pF}$ ,  $T_A = +25^\circ\text{C}$  (Cont.)



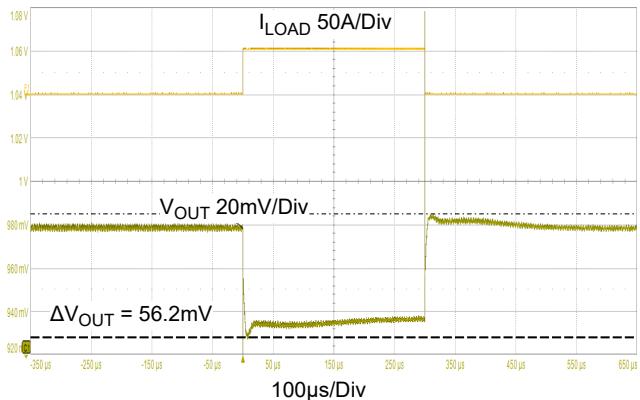
**Figure 23. Load Transient Response**  
( $P_{VIN} = V_{DD} = 5\text{V}$ )



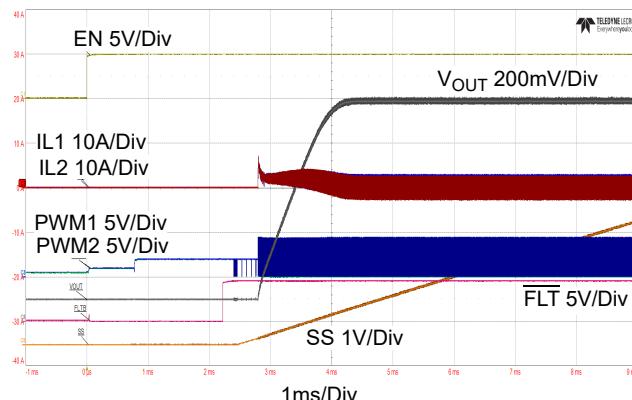
**Figure 24. Load Transient Response**  
( $P_{VIN} = V_{DD} = 5\text{V}$ ,  $R_{DROOP} = 604\Omega$ )



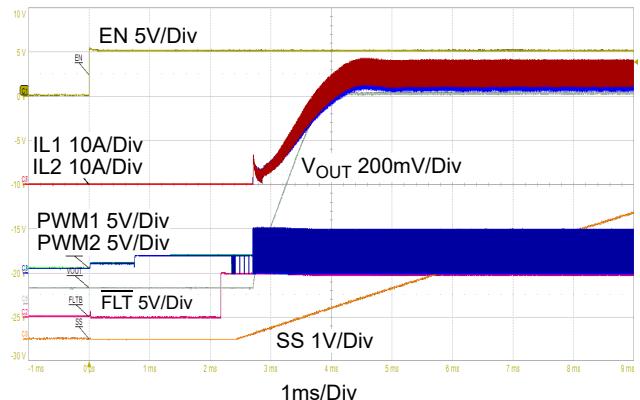
**Figure 25. Load Transient Response**  
( $P_{VIN} = V_{DD} = 12\text{V}$ )



**Figure 26. Load Transient Response**  
( $P_{VIN} = V_{DD} = 12\text{V}$ ,  $R_{DROOP} = 604\Omega$ )



**Figure 27. Start-Up with EN**  
( $P_{VIN} = V_{DD} = 4.62\text{V}$ ,  $I_{LOAD} = 0\text{A}$ )



**Figure 28. Start-Up with EN**  
( $P_{VIN} = V_{DD} = 4.62\text{V}$ ,  $I_{LOAD} = 50\text{A}$ )

Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220\text{nH}$  per phase,  $C_{OUT} = 2.64\text{mF}$  per phase,  $C_{DROOP} = 56\text{nF}$ ,  $C_{VREF} = 100\text{nF}$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2\text{k}\Omega$ ,  $C_{SS} = 22\text{nF}$ ,  $C_{COMP} = 8.2\text{nF}$ ,  $R_{COMP} = 4.22\text{k}\Omega$ ,  $C_{POLE} = 330\text{pF}$ ,  $C_{VCC} = 1\mu\text{F}$ ,  $R_{SLP} = 34.8\text{k}\Omega$ ,  $C_{SLP} = 100\text{pF}$ ,  $T_A = +25^\circ\text{C}$  (Cont.)

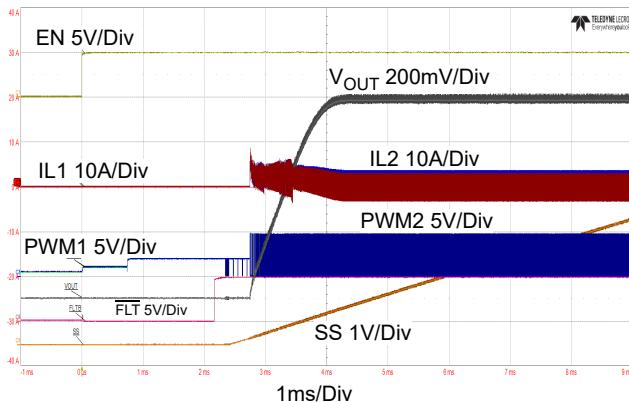


Figure 29. Start-Up with EN  
( $P_{VIN} = V_{DD} = 12\text{V}$ ,  $I_{LOAD} = 0\text{A}$ )

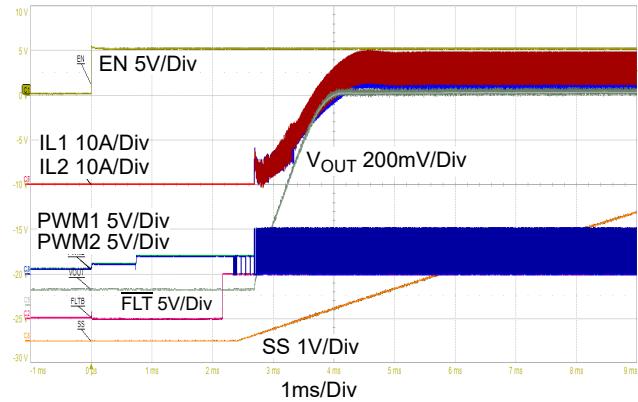


Figure 30. Start-Up with EN  
( $P_{VIN} = V_{DD} = 12\text{V}$ ,  $I_{LOAD} = 50\text{A}$ )

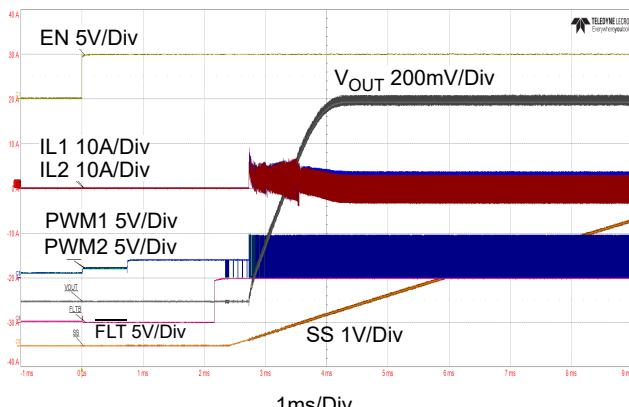


Figure 31. Start-Up with EN  
( $P_{VIN} = V_{DD} = 13.2\text{V}$ ,  $I_{LOAD} = 0\text{A}$ )

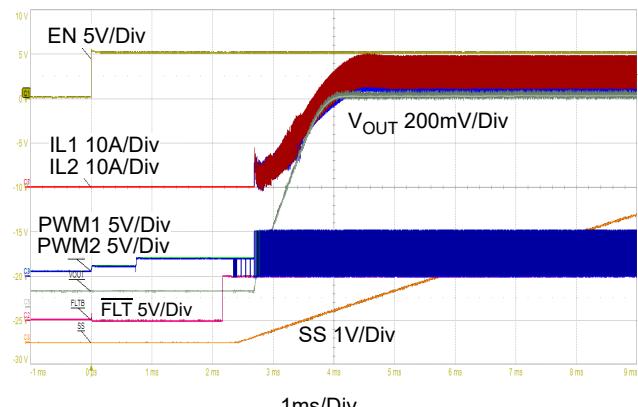


Figure 32. Start-Up with EN  
( $P_{VIN} = V_{DD} = 13.2\text{V}$ ,  $I_{LOAD} = 50\text{A}$ )

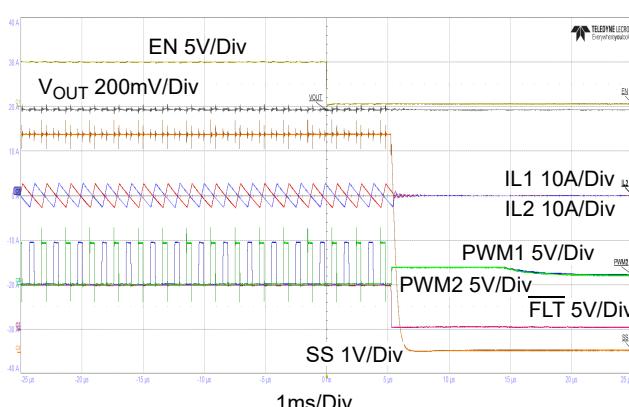


Figure 33. Shutdown with EN  
( $P_{VIN} = V_{DD} = 5\text{V}$ ,  $I_{LOAD} = 0\text{A}$ )

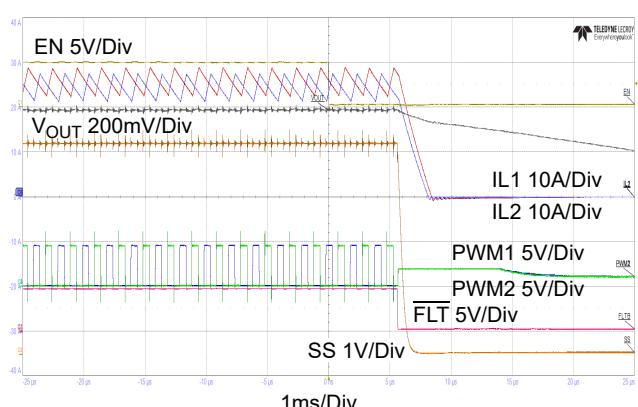
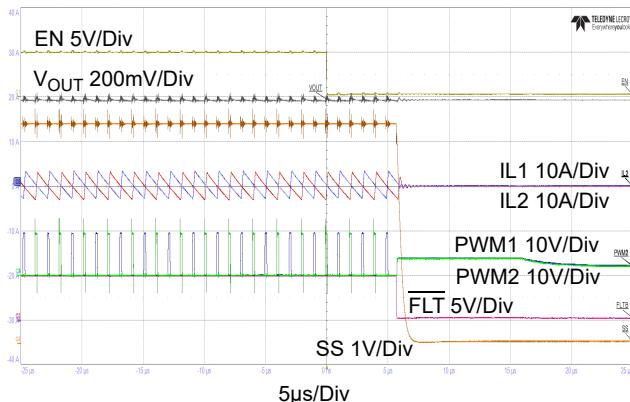
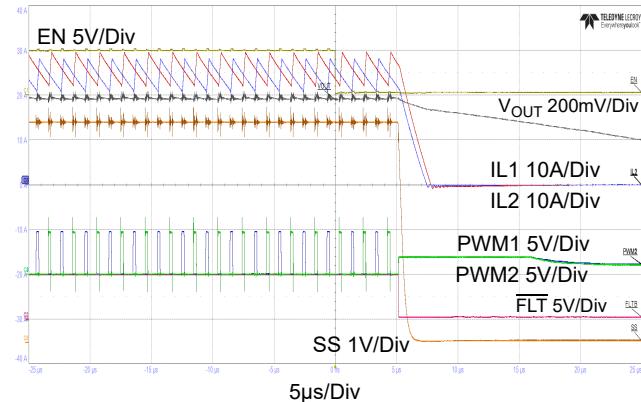


Figure 34. Shutdown with EN  
( $P_{VIN} = V_{DD} = 5\text{V}$ ,  $I_{LOAD} = 50\text{A}$ )

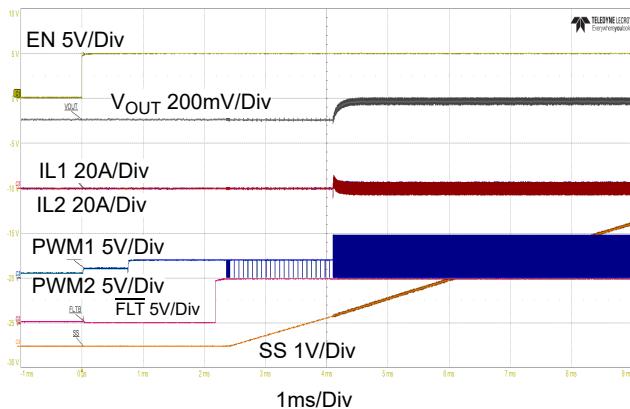
Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220nH$  per phase,  $C_{OUT} = 2.64mF$  per phase,  $C_{DROOP} = 56nF$ ,  $C_{VREF} = 100nF$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2k\Omega$ ,  $C_{SS} = 22nF$ ,  $C_{COMP} = 8.2nF$ ,  $R_{COMP} = 4.22k\Omega$ ,  $C_{POLE} = 330pF$ ,  $C_{VCC} = 1\mu F$ ,  $R_{SLP} = 34.8k\Omega$ ,  $C_{SLP} = 100pF$ ,  $T_A = +25^\circ C$  (Cont.)



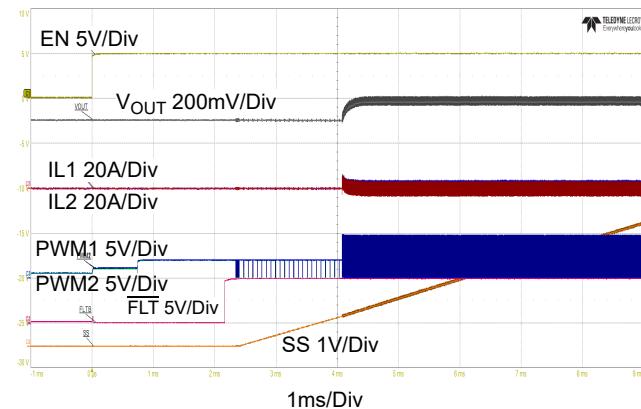
**Figure 35. Shutdown with EN**  
( $P_{VIN} = V_{DD} = 12V$ ,  $I_{LOAD} = 0A$ )



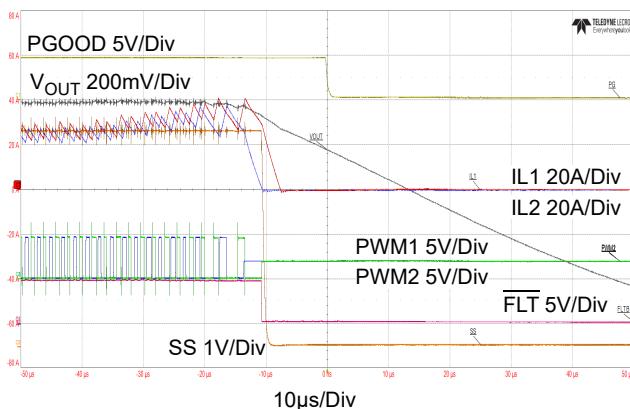
**Figure 36. Shutdown with EN**  
( $P_{VIN} = V_{DD} = 12V$ ,  $I_{LOAD} = 50A$ )



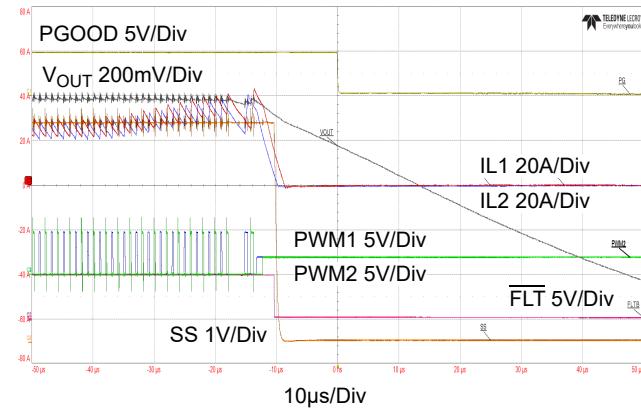
**Figure 37. Pre-Biased Start-Up**  
( $V_{DD} = 4.62V$ ,  $P_{VIN} = 12V$ ,  $I_{LOAD} = 0A$ ,  $V_{pre-bias} = 900mV$ )



**Figure 38. Pre-Biased Start-Up**  
( $P_{VIN} = V_{DD} = 12V$ ,  $I_{LOAD} = 0A$ ,  $V_{pre-bias} = 900mV$ )



**Figure 39. Overcurrent Protection** ( $P_{VIN} = 12V$ ,  $V_{DD} = 5V$ )



**Figure 40. Overcurrent Protection** ( $P_{VIN} = V_{DD} = 12V$ )

Unless otherwise noted,  $V_{OUT} = 1V$ ;  $L_{OUT} = 220\text{nH}$  per phase,  $C_{OUT} = 2.64\text{mF}$  per phase,  $C_{DROOP} = 56\text{nF}$ ,  $C_{VREF} = 100\text{nF}$ ,  $R_{DROOP} = 0\Omega$ ,  $R_{FS} = 94.2\text{k}\Omega$ ,  $C_{SS} = 22\text{nF}$ ,  $C_{COMP} = 8.2\text{nF}$ ,  $R_{COMP} = 4.22\text{k}\Omega$ ,  $C_{POLE} = 330\text{pF}$ ,  $C_{VCC} = 1\mu\text{F}$ ,  $R_{SLP} = 34.8\text{k}\Omega$ ,  $C_{SLP} = 100\text{pF}$ ,  $T_A = +25^\circ\text{C}$  (Cont.)

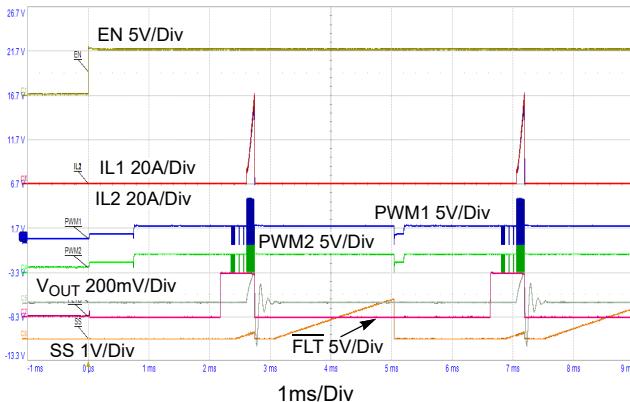


Figure 41. Start-Up with a Short ( $P_{VIN} = V_{DD} = 5\text{V}$ )

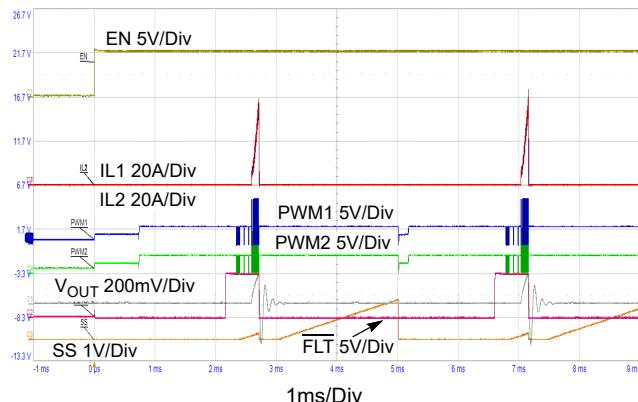


Figure 42. Start-Up with a Short ( $P_{VIN} = V_{DD} = 12\text{V}$ )

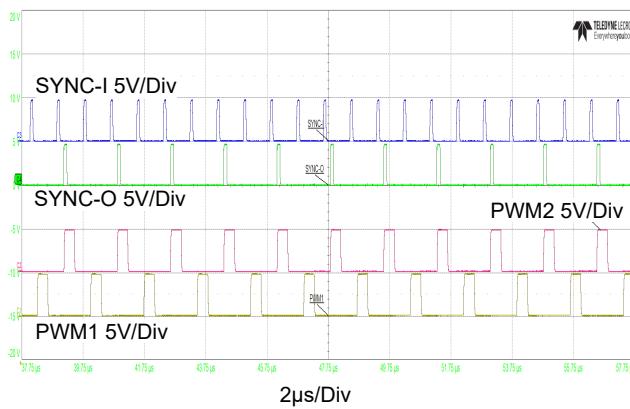


Figure 43. SYNC ( $V_{DD} = 5\text{V}$ ,  $P_{VIN} = 12\text{V}$ ,  $R_{SYNC-O} = 100\text{k}\Omega$  to VCC,  $F_{SYNC-I} = 1.15\text{MHz}$ )

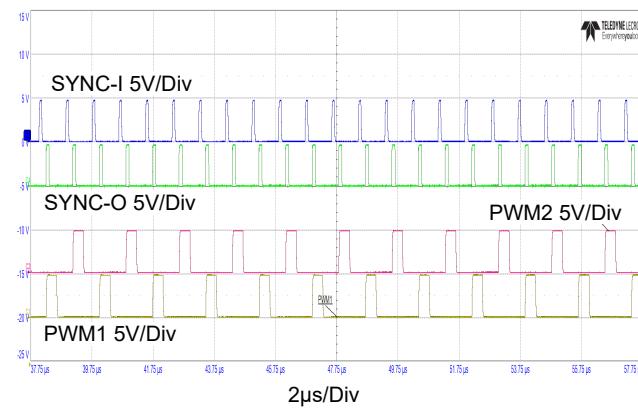


Figure 44. SYNC ( $V_{DD} = 5\text{V}$ ,  $P_{VIN} = 12\text{V}$ ,  $R_{SYNC-O} = 100\text{k}\Omega$  to GND,  $F_{SYNC-I} = 1.15\text{MHz}$ )

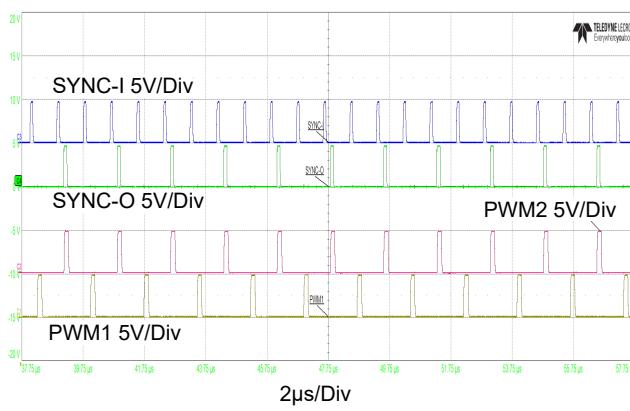


Figure 45. SYNC ( $V_{DD} = 12\text{V}$ ,  $P_{VIN} = 12\text{V}$ ,  $R_{SYNC-O} = 100\text{k}\Omega$  to VCC,  $F_{SYNC-I} = 1.15\text{MHz}$ )

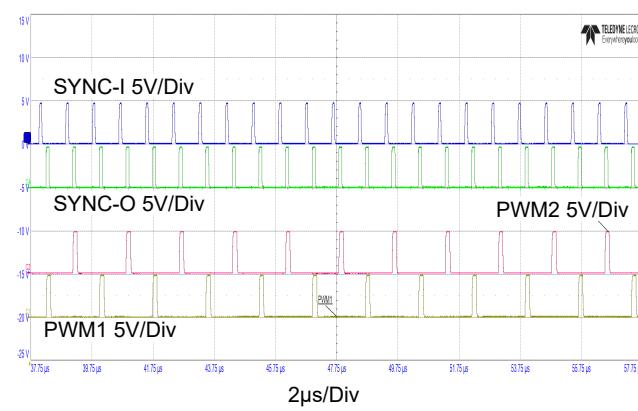


Figure 46. SYNC ( $V_{DD} = 12\text{V}$ ,  $P_{VIN} = 12\text{V}$ ,  $R_{SYNC-O} = 100\text{k}\Omega$  to GND,  $F_{SYNC-I} = 1.15\text{MHz}$ )

## 5. Operational Description

### 5.1 Dual Phase Operation

The ISL73847M can operate in single-phase or dual-phase mode. The part is configured to work in dual-phase mode by default. To operate in single-phase mode, short the PWM output to VCC. Either PWM1 or PWM2 can be chosen for single-phase operation if the other is shorted to VCC. The flexibility of using either output in single-phase can help during layout, as it may be easier to route the current-sense feedback signals to one channel or the other.

### 5.2 Oscillator and Clock Synchronization

The switching frequency of the controller is determined by a resistor to ground on the FS pin ( $R_{FS}$ ). The ISL73847M can operate with an oscillator frequency of 500kHz to 3MHz. If the FS pin is shorted to ground, the ISL73847M reads this as a fault and stops switching.

#### 5.2.1 External Synchronization (SYNC-I)

The ISL73847M has a SYNC-I pin that allows synchronizing it to an external clock. It is necessary to set the internal oscillator to 15% less than the required frequency of the external oscillator to use this functionality, ensuring that if the SYNC-I frequency stops at any point, the internal oscillator takes over and continues operating. The allowable frequency range for the external clock is 588kHz to 3MHz. The SYNC-I frequency should be twice the required PWM output switching frequency.

*Note:* The maximum SYNC-I frequency should not exceed the maximum oscillator frequency (3MHz).

#### 5.2.2 Clock Output (SYNC-O)

The ISL73847M has a SYNC-O pin that can output either the oscillator frequency or the PWM output switching frequency. Place a 100k $\Omega$  resistor on the SYNC-O pin to ground to output the oscillator frequency. Place a 100k $\Omega$  resistor on the SYNC-O pin to VCC to output the PWM output switching frequency. The choice to use one or the other depends on what is receiving the clock pulse. If the clock output is being used to synchronize another ISL73847M, it expects a frequency twice the PWM switching frequency (load the pin with 100k $\Omega$  to ground). Other PWM regulators such as the ISL7000x family of parts, switch at the same frequency as the incoming frequency (tie with 100k $\Omega$  to VCC). When SYNC-O is unloaded, it is in phase with PWM2. During a fault condition, the SYNC-O is asserted low.

#### 5.2.3 Multi-Phase Operation

More phases can be added to the system by connecting multiple ISL73847M devices together in a single leader, multi-follower configuration. To synchronize the two or more controllers external clocks can be supplied to the SYNC-I inputs. The frequency of the clocks should be twice the target switching frequency. The phase relationship between the clocks depends on the number of controllers being synchronized. Use [Equation 1](#) to calculate the recommended phase delay required between each SYNC-I clock depending on the number of controllers. The total phase delay should add up to 360°.

$$(EQ. 1) \quad \text{Phase[deg]} = \frac{360}{\text{Controllers}}$$

A simple way to synchronize a 4-phase design is to use the SYNC-O of the leader controller to drive the SYNC-I of the follower controller as shown in [Figure 47](#). The SYNC-O pin needs a 100k $\Omega$  to GND to output twice the switching frequency. Because the internal oscillator of the Follower must be set to 15% lower than the external clock, the RFS and RSLOPE resistors are different from the Leader. For a 1MHz switching frequency, the typical SYNC-I to SYNC-O delay of the leader controller creates the 180° phase delay required to drive the SYNC-I of the follower controller directly. As shown, tie the DROOP pins together, tie all the VFB- pins together, and tie all the

FLTb pins together. Tie the COMP pins of all controllers together and only install the compensation components on the leader. Lastly, tie the FB+ pin on each follower to its own DROOP pin.

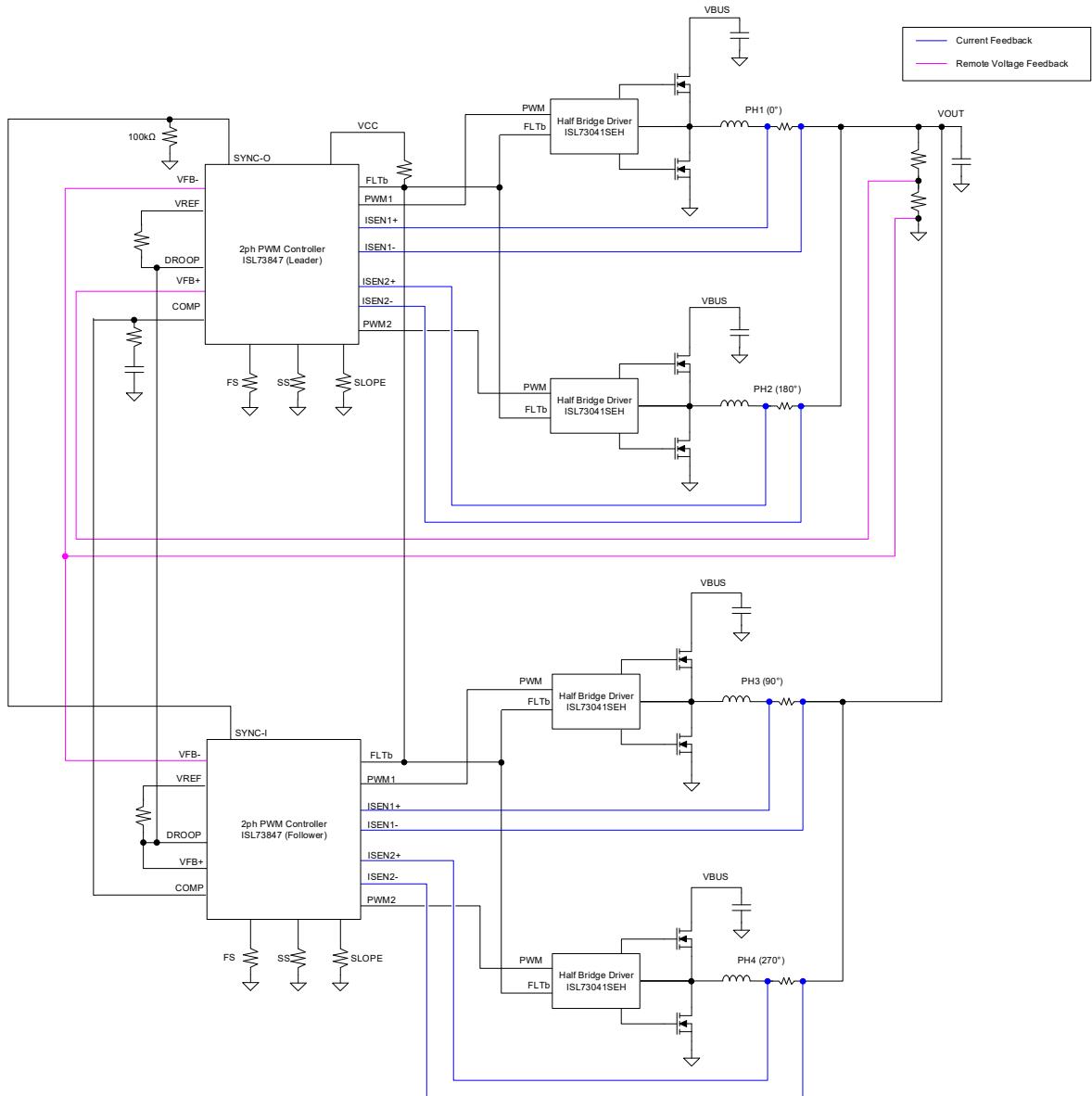


Figure 47. Leader-Follower Configuration for 1MHz 4-Phase Operation

Figure 48 is an oscilloscope capture where 93° phase separation is obtained between Phase 1 and Phase 3 by driving the SYNC-I of the follower with the SYNC-O of the leader directly with no extra delay circuit.

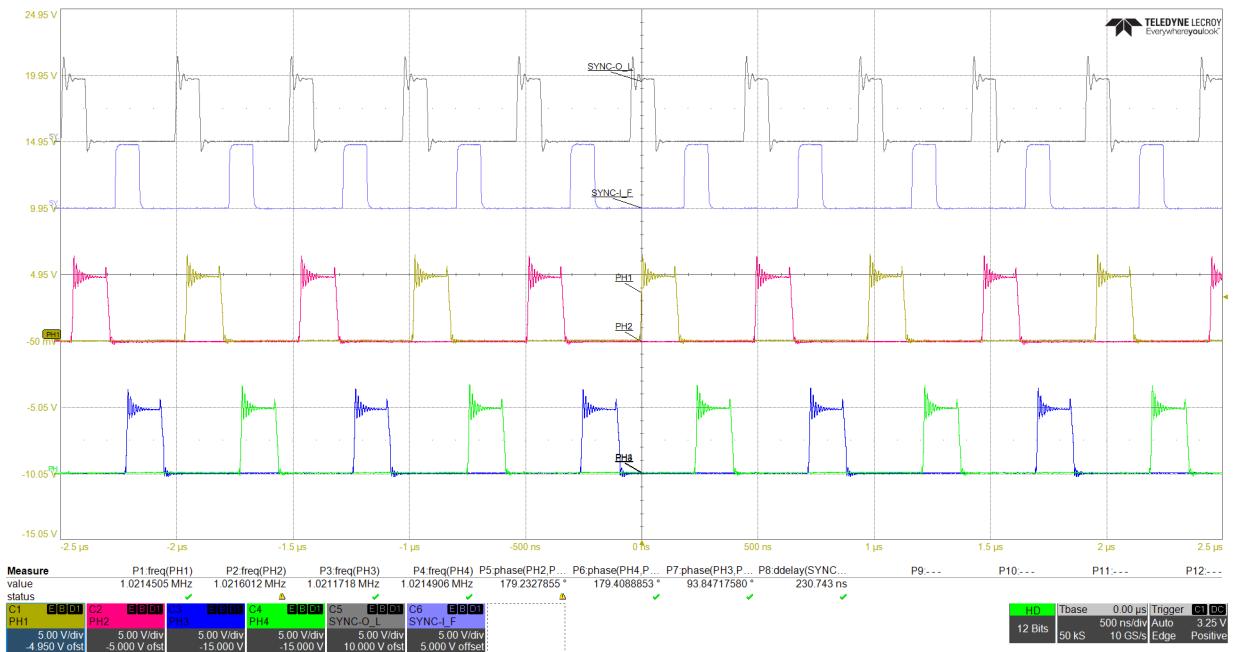


Figure 48. Using SYNC-O of Leader to drive SYNC-I of Follower Phase Shifting

For frequencies above 1MHz or phase counts over 4, an external delay circuit is required. This can be discreetly placed between the leader's SYNC-O and the follower's SYNC-I (Figure 49) or more flexibly with a smaller solution size using the ISL74420 (Figure 50).

Use Equation 2 to calculate the time delay from phase.

$$(EQ. 2) \quad \text{Delay} = \frac{\text{Phase}}{(720 \times f_{SW})}$$

- Delay is the time delay in seconds.
- Phase is the phase delay in degrees.
- $f_{SW}$  is the target switching frequency in Hertz.

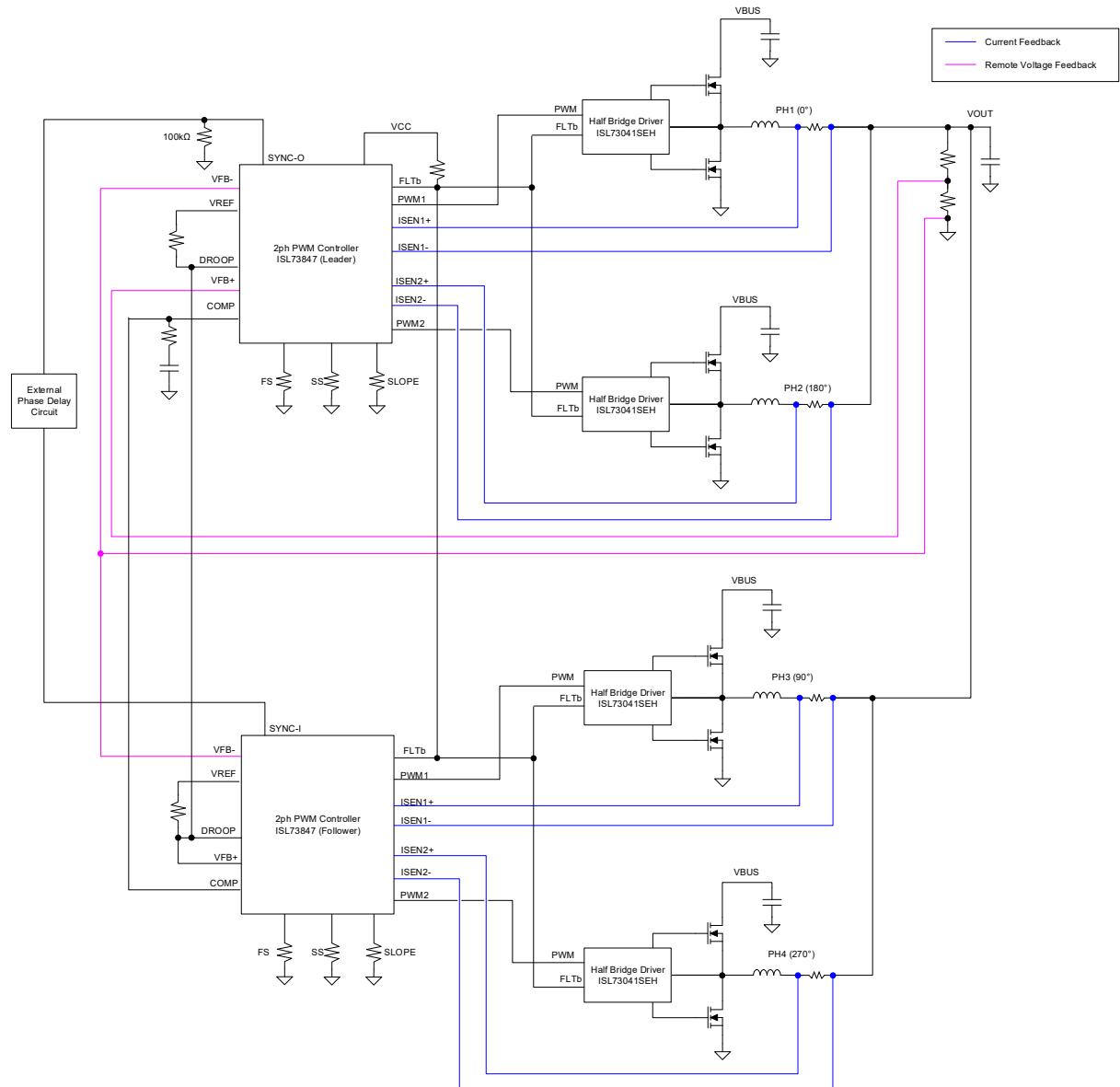
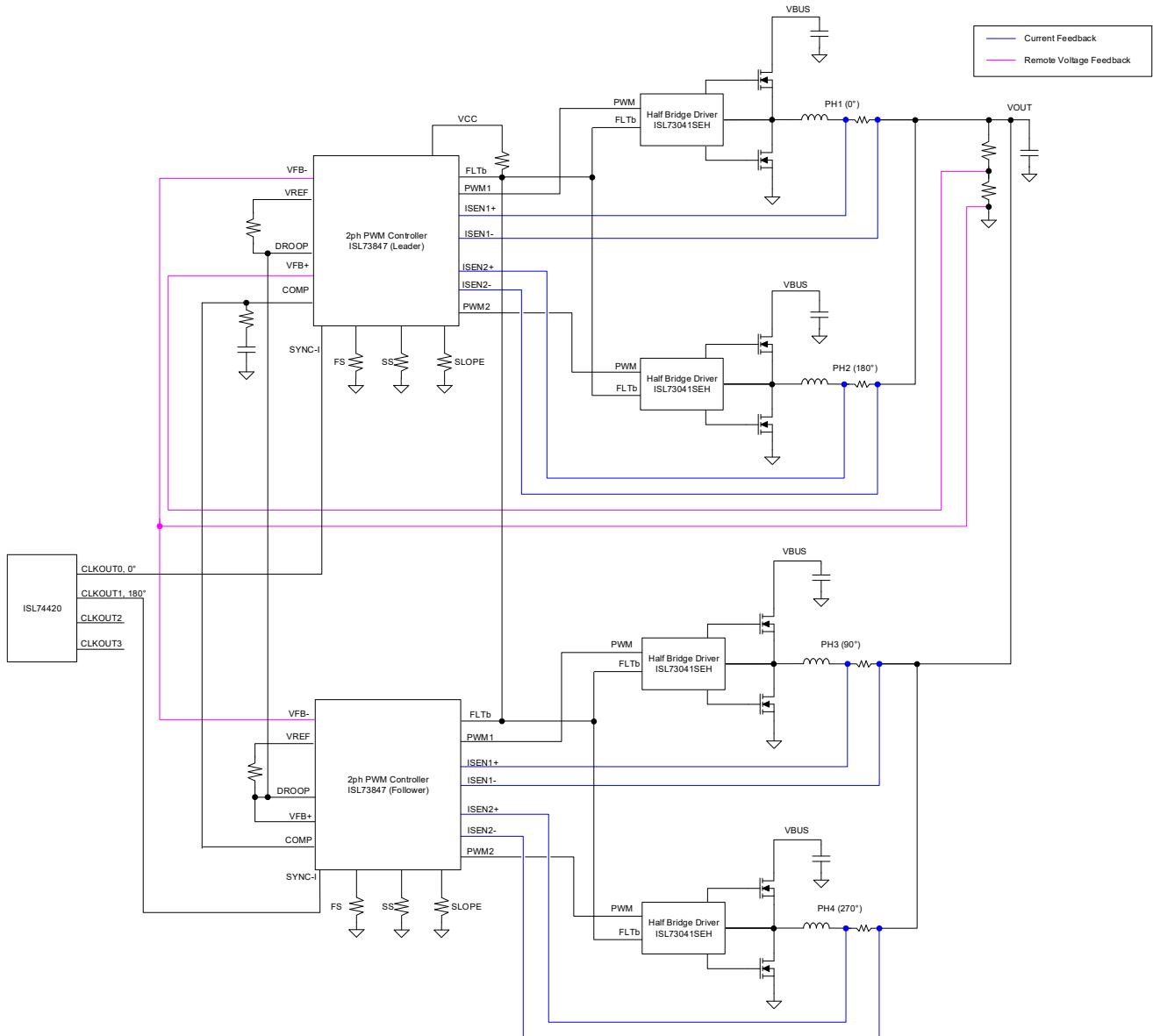


Figure 49. Leader-Follower Configuration for 4-Phase Operation

Another way to synchronize multiple ISL73847M devices is to use the ISL74420. Figure 50 is an example of a 4-phase using the ISL74420 to provide one clock to each controller. Both clocks are twice the converter switching frequency and 180° out-of-phase with each other for ideal multi-phase interleaving.



**Figure 50. Leader-Follower Configuration for 4-Phase Operation**

Figure 51 is an oscilloscope capture for a 4-phase, 1MHz, 5V to 0.8V, 100A reference design that uses the ISL74420 to output two 2MHz clocks, 180° out-of-phase for synchronization.

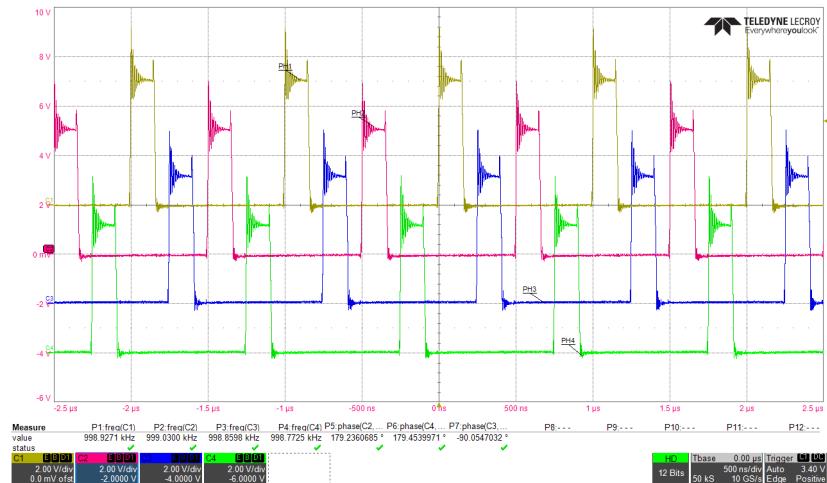


Figure 51. 4-Phase Clock Phase Shifting

### 5.3 Remote Sensing

The ISL73847M can provide differential remote sensing. This sensing allows for the power stage to reside close to the point of load and has the controller further away to reduce the possibility of noise injection because of switching noise from the power stage. In this configuration, the remote sensing also allows the ISL73847M to compensate for any loss along the copper planes carrying large currents.

### 5.4 Droop Regulation

Droop regulation can minimize transient voltages on the regulated output during large load steps. It lowers the output voltage as the load current increases, effectively increasing the DC output impedance for the power supply.

Droop regulation is tuned by adding a resistor between VREF and DROOP. The ISL73847M sinks a current on DROOP that is proportional to the sum of the differential voltage across both current sense inputs. This current through the resistor between VREF and DROOP changes the reference voltage presented to the error amplifier, thereby changing the DC regulation point. The larger the resistor, the greater the variation in regulated voltage with respect to the load current.

### 5.5 Peak Current Mode Control

The ISL73847M regulates peak current mode by presenting the current-sense signal directly to the PWM comparator. The current-sense amplifier has a minimum bandwidth of 10MHz, allowing it to keep up with the ripple current through the inductor. The PWM pulse is terminated when the current crosses the error amplifier output.

The ISL73847M has two identical peak mode control comparators, one for each set of PWM and ISEN pins. The matching between these two comparators is important to consider when setting the overcurrent thresholds of the part. The current sharing accuracy of the two phases is specified as the millivolts of offset between the phase's actual current and what that current would ideally be. For example, if a 50A load is pulled from a 2-phase system, ideally an average current of 25A per phase is achieved. With a 2mΩ sense resistor, that corresponds to 50mV on each pair of ISEN pins. A 4mV current sharing limit ( $I_{PHSHARE}$ ) means that one phase might be as high as 54mV, which corresponds to 27A of load current. The other phase must be 23A (or 46mV) to supply the 50A load.

### 5.6 Tri-State PWM Control

The ISL73847M features a tri-level PWM output with low-level, high-level, and mid-level voltage. The high-level output turns on the high-side FET, while a low-level output turns on the low-side FET, and the mid-level output

turns off both the high-side and low-side FETs. This state is helpful during fault conditions where you want to protect any downstream devices and the power stage. Connect a 100k $\Omega$  resistor on PWM1 and PWM2 to GND.

The ISL73847M works with drivers that accept a tri-level input, like the ISL71441M.

## 5.7 Boot Refresh

When the ISL73847M first powers up before soft-start, it issues a boot refresh command that consists of 32 mid-to-low transitions on the PWM output, allowing sufficient time for the boot capacitor to charge up. The switching frequency determines the frequency of the boot refresh pulses and the pulse is equal to the minimum on-time ( $t_{MIN\_ON}$ ). An appropriate boot capacitor value can be determined using the frequency and pulse widths.

Whenever the ISL73847M is tri-stated, it starts an analog timer that lasts 60 $\mu$ s  $\pm$ 60% (tolerance because of process and part-to-part variation). Four additional boot refresh pulses are transmitted if the timer completes before the next high-level signal to ensure the boot voltage is replenished. This would be the case in a pre-biased startup, where there could be significant time between the boot refresh pulses and the first high-side signal.

## 5.8 Current Sense Amplifiers and Current Monitoring (IMON)

The ISL73847M uses 10MHz (minimum) transconductance amplifiers for each phase to continuously achieve peak current control by sensing the inductor current. Current sensing can be accomplished using a shunt resistor on the output side of the inductor or through inductor DCR sensing. Shunt sensing provides high precision accuracy at the cost of power dissipation, while DCR current sensing has little power dissipation because of indirectly senses the inductor current. Its drawbacks include reduced accuracy across the operating temperature range and the inability to sense when an inductor is saturating; therefore, Renesas recommends using soft saturation inductors.

The ISL73847M has an IMON pin that monitors the current through the power supply for telemetry purposes. Connect a resistor from the IMON pin to GND. In this configuration, the IMON pin reflects the average of the inductor ripple current. An additional capacitor in parallel with the resistor can improve averaging. The size of the capacitor needed to average the current depends on the ripple seen on the IMON pin.

## 5.9 Adjustable Slope Compensation

The ISL73847M is a peak current mode controller prone to subharmonic oscillations when the duty cycle exceeds 50%. Adding a compensating ramp equal to the downslope of the inductor current can dampen any subharmonic oscillation within one switching cycle. Renesas recommends using adequate slope compensation if the nominal duty is under but close to 50%, as the duty cycle could cross 50% as the load increases. The slope compensation depends on the SLOPE pin and the FS pin.

If slope compensation is insufficient, the converter can experience subharmonic oscillation that could result in noise emissions at half the switching frequency. However, too much slope compensation can deteriorate the phase margin; therefore, slope compensation must be carefully considered.

## 5.10 Pulse Skipping

The ISL73847M can skip pulses if the feedback indicates excessive minimum pulse width. One scenario where this can arise would be during a load release when operating close to the minimum on-time. Pulse skipping reduces the overshoot during the unloading in a transient step.

## 5.11 VDD and VCC Range

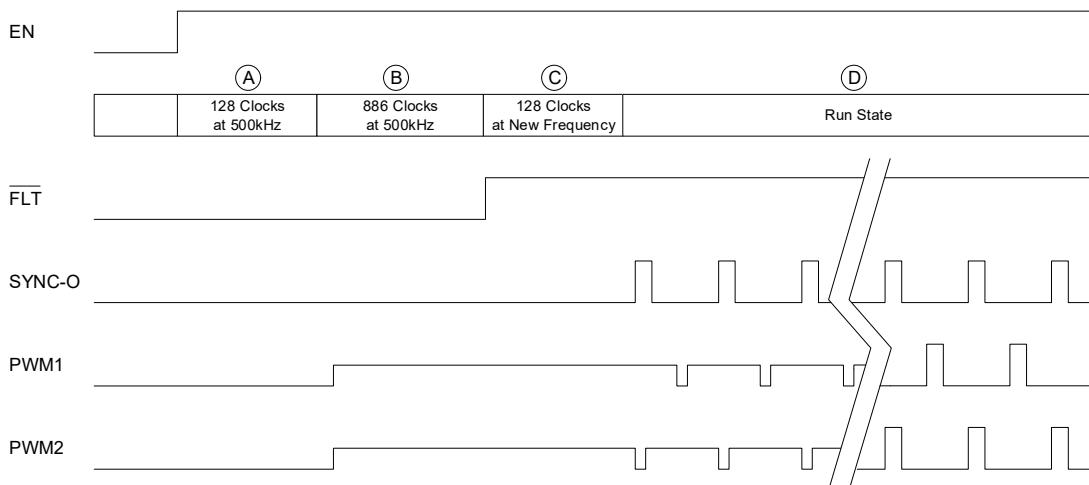
The ISL73847M has an internal LDO that provides the bias for all internal circuitry. The input of the LDO is VDD, which accepts a range of 4.5V up to 19V. VCC is the output of the LDO, which regulates 5V. When VDD is operating in the range of 4.5V to 5.0V, VCC tracks VDD minus the dropout.

## 5.12 Enable

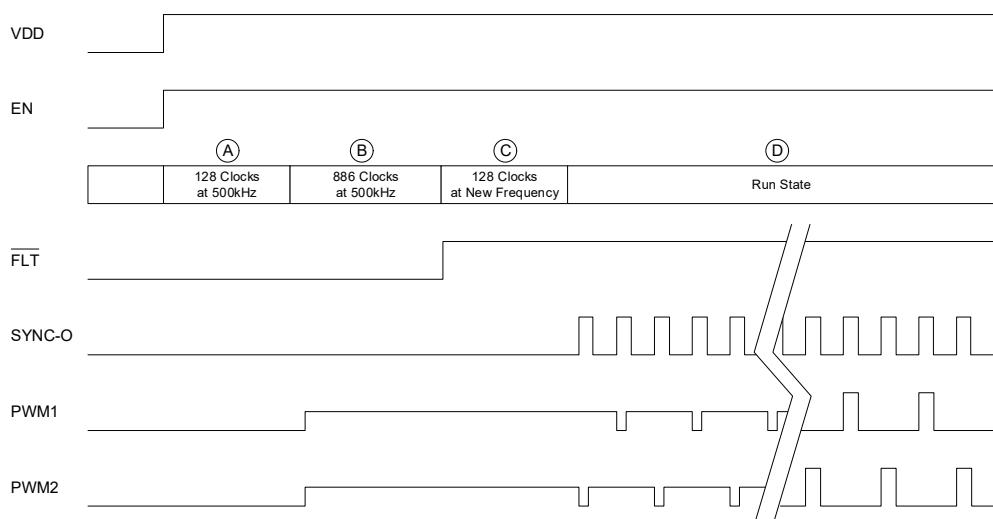
The ISL73847M features a 2-stage enable. When enable is at 1V (gross threshold), the internal circuitry is biased (such as reference voltage, oscillator, and logic) but switching is disabled. When the voltage of EN crosses the fine threshold, switching is enabled, and the IC attempts a boot refresh and soft-start. Because of filtering for Single Event Effects (SEE), the EN logic state (high or low) must persist for at least 80 $\mu$ s for the part to recognize it and respond. The enable pin has a pull-down that disables the part if the pin is not actively driven.

## 5.13 Initialization and Startup

When the ISL73847M first powers up, it goes through several states before boot refresh and soft-start. After VDD has crossed the rising UVLO threshold, the oscillator waits for 128 clock cycles at 500kHz before allowing the digital core to enter its configuration state. The configuration state lasts 886 clock cycles at 500 kHz. When the digital core completes its configuration, it signals the oscillator to switch to the frequency set by the FS pin or SYNC-I. After an additional 128 clock cycles at the new frequency, boot refresh pulses commence, followed by soft-start. [Figure 52](#) and [Figure 53](#) illustrate the start-up sequence.



**Figure 52. Start-Up Timing Diagram ( $R_{SYNC-O} = OPEN$ )**



**Figure 53. Start-Up Timing Diagram ( $R_{SYNC-O} = 100k\Omega$ )**

During states A and C in [Figure 52](#) and [Figure 53](#), the oscillator blanks the clock signal to the digital core. Therefore, the oscillator has time to stabilize its frequency before entering the configuration state (B) or run state (D).

**IMPORTANT:** During states A and C, the digital core does not receive a clock; therefore, it cannot detect a rising edge on EN. Instead, the EN signal must persist long enough so the digital core can read it during states B and D. The ISL73847M reacts to a falling edge on EN regardless of the controller's state.

## 5.14 Hiccup

Any time the ISL73847M encounters a fault, it enters hiccup mode. During hiccup mode, the controller waits for one soft-start cycle before attempting to start switching again. If the fault has not cleared after the dummy soft-start cycle has completed, the ISL73847M waits until it clears and starts the PWM output switching. This would be the case if the fault that tripped was the driver pulling  $\overline{\text{FLT}}$  low because of an over-temperature fault.

If an output short occurs, the part would hiccup, go through a dummy soft-start cycle, and attempt to start up indefinitely until the output short is removed. In this case, as soon as the part starts switching, it would trip the gross overcurrent threshold and go back to hiccup. When the output short is removed, normal operation resumes after the configuration sequence, which is 886 clock cycles at 500kHz.

## 5.15 Fault Handling

### 5.15.1 Cycle-by-Cycle Current Limit

The current flowing through the inductor is monitored through the current-sense inputs using a sense resistor or DCR sensing. When the input reaches the current limit threshold ( $V_{\text{PCL}}$ ), the PWM pulse is terminated to limit the peak current. A single cycle-by-cycle current limit event does not trigger a hiccup, but if there are four current limit events in an eight-clock cycle window, the ISL73847M enters a hiccup.

### 5.15.2 Inductor Peak Overcurrent Protection

If the output current increases after triggering the cycle-by-cycle current limit, the ISL73847M has a second overcurrent protection ( $V_{\text{POC}}$  and  $V_{\text{NOC}}$ ). If triggered, it drives the PWM outputs to mid-level (tri-state the power stage) and enters a hiccup. If the initial fault persists or another fault occurs during the next soft-start, the cycle repeats indefinitely and stays in hiccup. The overcurrent protection protects against both positive and negative overcurrent conditions.

### 5.15.3 Overvoltage and Undervoltage Fault

The ISL73847M has overvoltage and undervoltage protection, which triggers when  $V_{(\text{FB}, \text{OV})}$  or  $V_{(\text{FB}, \text{UV})}$  is exceeded. If the  $V_{(\text{FB}, \text{OV})}$  or  $V_{(\text{FB}, \text{UV})}$  levels are reached, the part enters a hiccup.

### 5.15.4 $\overline{\text{FLT}}$ Pin

The  $\overline{\text{FLT}}$  pin (FLT stands for Fault) is a bi-directional communication pin between the ISL73847M controller and the ISL71441M driver. On the ISL73847M, the  $\overline{\text{FLT}}$  pin is low and is an I/O when the part is not ready (during startup) or encounters a fault. The ISL71441M uses this pin to communicate if it is not ready to accept input or encounters a fault on its end. In either case, if the  $\overline{\text{FLT}}$  pin is pulled low by the ISL71441M, the ISL73847M sets its PWM outputs to mid-level and enters a hiccup. PWM at mid-level tells the ISL71441M to turn off both of its FET outputs. The  $\overline{\text{FLT}}$  pin is an input while switching (during and after startup).

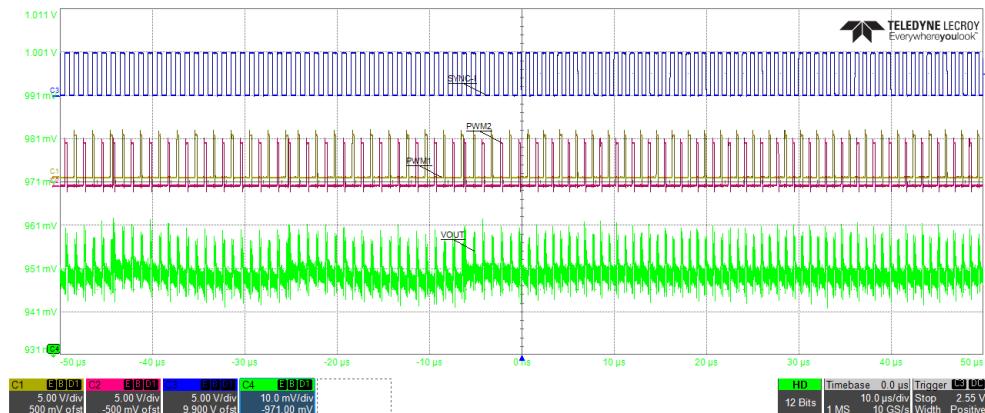
*Note:* The [FLT Mid Threshold Voltage](#) in the Electrical Characteristic table is the same as the [FLT Falling Threshold](#).

### 5.15.5 Oscillator and Sync Input Fault

If the FS pin is inadvertently shorted to ground, this causes a fault in the controller, and switching would be inhibited.

The ISL73847M can synchronize to an external frequency. If the external clock is not present or if the internal clock frequency is not less than 15% of the required external clock frequency, the part reverts to the internal oscillator and continues operation. When the external sync input returns or if the internal clock frequency is less

than 15% of the required external clock frequency, the ISL73847M immediately switches back to the external clock, as shown in [Figure 54](#).



**Figure 54. Switching between Internal Oscillator and External Oscillator on SYNC-I  
(External clock frequency changed from 1MHz to 1.15MHz)**

While switching between the internal and external oscillators, there may be a glitch observed on the regulated output. The size of this glitch depends on the frequency difference between the internal and external clock, output capacitance, and output loading.

The internal oscillator must be configured to operate 15% slower than the minimum external frequency applied to the SYNC-I pin to ensure that this fail safe works accordingly,. Setting the internal oscillator to a frequency that is too close to the external sync frequency can result in the clock output alternating between the internal and external clock, resulting in a beat frequency.

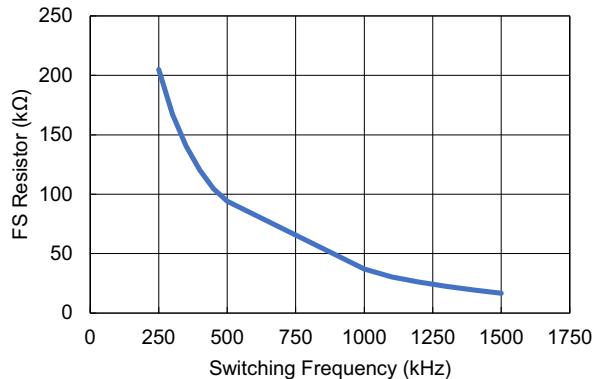
If the SYNC-I function is unnecessary, leave the pin floating as it has an internal pull-down. If whatever is driving the SYNC-I pin gets stuck in either a logic high or low, and as long as there are no transitions, the ISL73847M reverts to the internal oscillator.

## 6. Applications Information

### 6.1 PWM Output Switching Frequency Selection

The PWM output switching frequency is half the frequency of the internal oscillator. This is done to obtain a precise 180° phase shift between phases. The switching frequency is determined based on the requirements of the regulator size, power dissipation, and conversion ratio, where minimum controllable on/off times should be considered. Increasing the switching frequency reduces the solution size but, at the same time, increases switching losses. A balance must be reached between these parameters to decide the optimal switching frequency.

When the switching frequency is determined, the FS resistor (frequency setting resistor) can be determined by using [Equation 3](#). Renesas recommends using precision resistors to set the oscillator frequency as variations in the resistor increase the oscillator frequency spread.



**Figure 55.  $R_{FS}$  vs Frequency**

The oscillator frequency is determined by a resistor to ground on the FS pin where  $R_{FS}$  is in kilohms (kΩ) for a desired switching frequency  $f_{SW}$  in kilohertz (kHz).

$$(EQ. 3) \quad R_{FS}[k\Omega] = \frac{56497}{f_{SW}[kHz]} - 20.96$$

**IMPORTANT:** [Equation 3](#) approximates the real data presented in [Figure 55](#). The data used for [Figure 55](#) is typical, and there is some variation because of temperature and variation. This variation is shown in the electrical specifications table by providing four fixed resistors and the frequency and tolerance achieved with those resistors.

## 6.2 Output Voltage Setting

Use [Equation 4](#) to calculate the required regulated output voltage. For greater voltage accuracy, Renesas recommends using 0.1% feedback resistors.

$$(EQ. 4) \quad V_{OUT} = V_{REF} \times \left(1 + \frac{R_2}{R_1}\right)$$

- $V_{OUT}$  is the required regulated output voltage.
- $V_{REF}$  is the internal reference voltage on the VFB+ pin, which is 0.6V (typical).
- $R_1$  is the bottom resistor in the feedback divider.
- $R_2$  is the top resistor in the feedback divider.

## 6.3 Resistor Current Sensing and Monitoring Setting

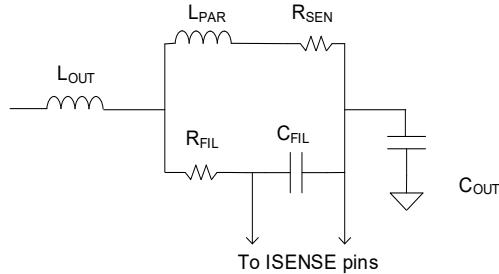
The ISL73847M can sense current through a shunt resistor or DCR sensing. Use [Equation 5](#) to determine the required shunt resistance or minimum DCR of the inductor. Depending on what  $P_{V_{IN}}$ ,  $V_{OUT}$ , and  $I_{OUT(MAX)}$  are, DCR sensing might not be practical. For example, in a high current and low output voltage application, getting an inductor that meets both the minimum DCR requirement and the saturation current capability might not be possible. In this case, shunt sensing is the only option.

$$(EQ. 5) \quad R_{SEN} = \frac{V_{SEN} \times n}{I_{OUT(MAX)}}$$

- $R_{SEN}$  is the sense resistor or DCR of the inductor.
- $n$  is the number of phases (for the ISL73847M this is either 1 or 2).

- $I_{OUT(MAX)}$  is the max DC output current for all phases.
- $V_{SEN}$  is the target current-sense amplifier input voltage during steady-state operation, which is 50mV (typical).

It is necessary to add RC filters for the sense resistor and DCR sensing. In the case of the sense resistor, it is to compensate for the parasitic inductance. Use [Equation 6](#) to calculate the RC filter if the resistance and parasitic inductance of the sense resistor are known. For DCR sensing, the RC filter has to be properly selected such that the voltage across the cap is proportional to the current through the inductor.



**Figure 56.  $R_{SEN}$  Parasitic Inductance Compensation RC Circuit**

$$(EQ. 6) \quad \frac{L_{PAR}}{R_{SEN}} = R_{FIL} \times C_{FIL}$$

- $R_{FIL}$  is the resistance of the resistor in the RC filter.
- $C_{FIL}$  is the capacitance of the capacitor in the RC filter.
- $R_{SEN}$  is the sense resistor from [Equation 5](#).
- $L_{PAR}$  is the parasitic inductance of  $R_{SEN}$ .

The ISL73847M continuously monitors the inductor current of each phase. The IMON pin outputs a current proportional to the summation of current from both phases.

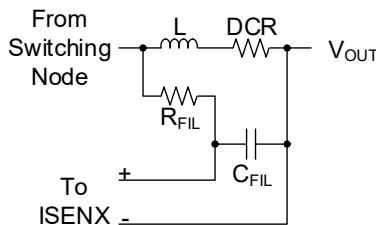
$$(EQ. 7) \quad I_{MON} = \sum_{n=1}^2 R_{SEN} \times I_{Ln} \times g_m(CSA, IMON)$$

- $I_{MON}$  is the current out of the IMON pin.
- $R_{SEN}$  is the sense resistor calculated from [Equation 5](#).
- $I_{Ln}$  is the inductor current for a given phase, where  $n$  is the phase number.
- $g_m(CSA, IMON)$  is the transconductance from the input of the current sense amp to the IMON pin, which is 0.39 $\mu$ A/mV (typical).

## 6.4 DCR Current Sensing

The DCR method of current sensing in a buck converter uses the DC resistance of the inductor winding as the current sense element. This method eliminates the need for a sense resistor and improves efficiency. The inductor DCR does vary based on the temperature coefficient of the selected winding material, such as Cu. However, these variations are not quite as wide as using a MOSFET for  $r_{DS(ON)}$  sensing. This method is often used in low-output voltage converters, as any voltage drop on a sense resistor negates the low-output voltage. Keep in mind that DCR sensing is not recommended for current-sharing applications.

If the  $DCR = R_{SEN}$ , place an RC filter across the inductor, as shown in [Figure 57](#).



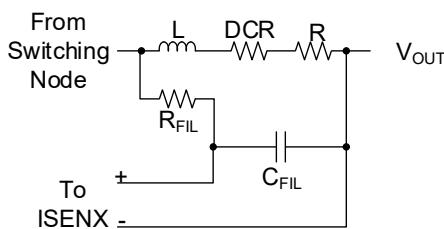
[Figure 57. DCR Current Sensing when  \$DCR = R\_{SEN}\$](#)

Calculate the component values using [Equation 8](#):

$$(EQ. 8) \quad \frac{L}{DCR} = R_{FIL} \times C_{FIL}$$

- $L$  is the output inductor value.
- $DCR$  is the DC resistance of inductor winding.
- $R_{FIL}$  is the resistor value selected for DCR sensing and filtering.
- $C_{FIL}$  is the capacitor value selected for DCR sensing and filtering.

If  $DCR < R_{SEN}$ , a resistor can be added to get the required  $R_{SEN}$ , as shown in [Figure 58](#).



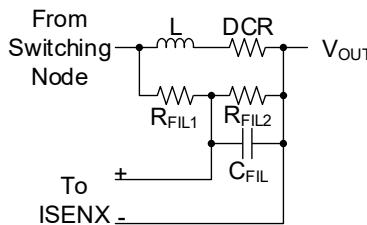
[Figure 58. DCR Current Sensing when  \$DCR < R\_{SEN}\$](#)

Calculate the component values using [Equation 9](#). For example, if  $R_{SEN}$  is  $2m\Omega$  and the chosen inductor has a  $DCR$  of  $1m\Omega$ , a  $25mV$  current sense signal is produced instead of a  $50mV$  signal. To fix this, add  $R = 1m\Omega$  in series with the inductor to get a  $R_{SEN} = 2m\Omega$ .

$$(EQ. 9) \quad \frac{L}{DCR + R} = R_{FIL} \times C_{FIL}$$

- $L$  is the output inductor value.
- $DCR$  is the DC resistance of inductor winding.
- $R$  is the added resistor in series with the inductor.
- $R_{FIL}$  is the resistor value selected for DCR sensing and filtering.
- $C_{FIL}$  is the capacitor value selected for DCR sensing and filtering.

If  $DCR > R_{SEN}$ , a voltage divider must be added to the current sense filter to obtain the required  $R_{SEN}$ , as shown in [Figure 59](#).



**Figure 59. DCR Current Sensing when  $DCR > R_{SEN}$**

Calculate the component values using [Equation 10](#). For example, if  $R_{SEN}$  is  $2m\Omega$  and the chosen inductor has a DCR of  $3m\Omega$ , a  $75mV$  current sense signal is produced instead of a  $50mV$  signal. To fix this, use an  $R_{FIL1} = 1k\Omega$  and  $R_{FIL2} = 2k\Omega$  divider to reduce the  $75mV$  current sense signal to  $50mV$ .

$$(EQ. 10) \quad \frac{L}{DCR} = \frac{R_{FIL1} \times R_{FIL2}}{R_{FIL1} + R_{FIL2}} \times C_{FIL}$$

- $L$  is the output inductor value.
- $DCR$  is the DC resistance of inductor winding.
- $R_{FIL1}$  and  $R_{FIL2}$  are the resistor values selected for DCR sensing and filtering.
- $C_{FIL}$  is the capacitor value selected for DCR sensing and filtering.

## 6.5 Inductor Selection

To select the proper inductance value, determine the input voltage, output voltage, switching frequency, and inductor ripple current. Renesas recommends ensuring the inductor ripple current is 30%.

$$(EQ. 11) \quad I_{OUT} = n \times I_{PHASE}$$

- $n$  is the number of phases (for the ISL73847M this is either 1 or 2).
- $I_{PHASE}$  is the phase current.

Designing with less ripple current reduces the output voltage ripple but comes at the expense of slower transient response. Therefore, the amount of acceptable ripple would need to be decided on a per-application basis.

Use [Equation 12](#) to calculate a good first-pass estimate for the inductor size.

$$(EQ. 12) \quad L_{REC} = \frac{(V_{IN} - V_{OUT}) \times D \times n}{k \times f_{SW} \times I_{OUT}}$$

- $L_{REC}$  is the recommended inductance.
- $V_{IN}$  is the input voltage to the power supply.
- $V_{OUT}$  is the output voltage of the power supply.
- $D$  is the duty cycle; for a buck converter, it is  $(V_{OUT}/V_{IN})$ .
- $k$  is the inductor ripple to DC current ratio ( $k = 0.3$  is recommended).
- $n$  is the number of phases (for the ISL73847M this is either 1 or 2).
- $f_{SW}$  is the switching frequency of the power supply.
- $I_{OUT}$  is the output current of the regulator.

## 6.6 Slope Compensation

Use [Equation 13](#) to calculate the slope compensation resistor:

$$(EQ. 13) \quad R_{SLOPE} = \frac{R_{SEN} \times R_{FS} \times V_{OUT}}{k \times L_{SEL}}$$

$$25\text{k}\Omega \leq R_{SLOPE} \leq 100\text{k}\Omega$$

- $R_{SLOPE}$  is the slope compensation resistor.
- $R_{SEN}$  is the value of the current sensing resistor.
- $R_{FS}$  is the value of the resistor that sets the switching frequency.
- $V_{OUT}$  is the output voltage of the power supply.
- $k$  is a constant, 25kV/s.
- $L_{SEL}$  is the user-selected output inductance.

The  $R_{SLOPE}$  value must stay within 25k $\Omega$  to 100k $\Omega$  for proper operation of the internal circuitry. If  $R_{SLOPE}$  is less than 25k $\Omega$ ,  $L_{SEL}$  must be decreased; If  $R_{SLOPE}$  is greater than 100k $\Omega$ ,  $L_{SEL}$  must be increased.

## 6.7 Error Amplifier Compensation and Output Capacitance

To calculate the output capacitor and compensation values, the transient response  $\Delta V_{OUT}$  and transient current step  $\Delta I_{OUT}$  must be known. With these two known values, use [Equation 14](#) to calculate the equivalent load-line output impedance  $R_{LL}$ .

$$(EQ. 14) \quad R_{LL} = \frac{\Delta V_{OUT}}{\Delta I_{OUT}}$$

As an example, if a regulator needs to meet a 5% transient specification for  $V_{OUT} = 1\text{V}$  and  $\Delta I_{OUT} = 50\text{A}$ ,  $\Delta V_{OUT}$  is 50mV ( $1\text{V} \times 5\%$ ), which would make  $R_{LL} = 50\text{mV}/50\text{A} = 1\text{m}\Omega$ .

The error amplifier is a transconductance amplifier that makes it much easier to compensate by placing a series resistor and capacitor on the output of the amplifier (COMP pin). Use [Equation 15](#) to determine the compensation resistor ( $R_{COMP}$ ).

$$(EQ. 15) \quad R_{COMP} = \frac{V_{OUT} \times R_{SEN} \times A_{CSA}}{n \times V_{REF} \times g_{m(EA)} \times R_{LL}}$$

- $R_{COMP}$  is the COMP pin resistor.
- $R_{SEN}$  is the sense resistor or minimum DCR of the inductor.
- $A_{CSA}$  is the gain of the current sense amplifier, which is 8mV/mV (typical).
- $n$  is the number of phases (for the ISL73847M this is either 1 or 2).
- $V_{REF}$  is the internal reference voltage on the VFB+ pin, which is 0.6V (typical).
- $g_{m(EA)}$  is the transconductance of the error amplifier, which is 3.57mA/V or 3.57mS (typical).
- $R_{LL}$  is the equivalent load-line output impedance calculated with [Equation 14](#).

The output capacitance determines the unity gain frequency  $f_T$ . Renesas recommends setting the unity gain frequency a decade below the switching frequency ( $f_T = f_{SW}/10$ ). After selecting real output capacitors, rearrange [Equation 16](#) to solve for  $f_T$  and recalculate the actual unity gain frequency ( $f_T$ ).

$$(EQ. 16) \quad C_{OUT(MIN)} = \frac{n \times R_{COMP} \times g_{m(EA)} \times V_{REF}}{2\pi \times f_T \times A_{CSA} \times R_{SEN} \times V_{OUT}}$$

- $C_{OUT(MIN)}$  is the minimum output capacitance needed for the required unity gain frequency of the regulator.
- $R_{COMP}$  is the COMP pin resistor calculated in [Equation 15](#).
- $V_{REF}$  is the internal reference voltage on the VFB+ pin, which is 0.6V (typical).
- $V_{OUT}$  is the output voltage of the power supply.
- $f_T$  is the unity gain frequency of the regulator, typically  $f_T = f_{SW}/10$ .
- $R_{SEN}$  is the sense resistor or minimum DCR of the inductor.
- $A_{CSA}$  is the gain of the current sense amplifier, which is 8mV/mV (typical).

Equations for  $R_{COMP}$  and  $C_{OUT(MIN)}$  are derived for an ideal case where the output capacitance has no parasitic ESR and ESL. The actual equivalent output capacitance has some parasitic ESR and ESL that impact the transient response. Use [Equation 17](#) to approximate the total transient response.

$$(EQ. 17) \quad \Delta V_{OUT(TOTAL)} = \Delta V_{OUT} + \Delta V_{ESR} + \Delta V_{ESL}$$

- $\Delta V_{OUT}$  is the value in [Equation 14](#) used for calculating  $R_{LL}$ .
- $\Delta V_{ESR}$  is the output voltage deviation due to the equivalent parasitic ESR, calculated in [Equation 18](#).

$$(EQ. 18) \quad \Delta V_{ESR} = \Delta I_{OUT} \times ESR$$

- $\Delta V_{ESL}$  is the output voltage deviation due to the equivalent parasitic ESL, calculated in [Equation 19](#), where  $di/dt$  is the slew rate of the transient step.

$$(EQ. 19) \quad \Delta V_{ESL} = ESL \times di/dt$$

**Note:** [Equation 17](#) is a rough estimate because these three components that affect the transient response never have maximum values simultaneously. Therefore, it should be clear that the ideal  $\Delta V_{OUT}$  calculated in [Equation 14](#) must be reduced to account for parasitic ESR and ESL in the output capacitors. For example, for a design goal of 5% total transient response, if both  $\Delta V_{ESR}$  and  $\Delta V_{ESL}$  are causing 1%  $V_{OUT}$  disturbance each, the real  $\Delta V_{OUT}$  used in [Equation 14](#) should be 3% (5%-2%).

$C_{COMP}$  sets the zero frequency of the error amplifier. To maximize the phase margin of the regulator, Renesas recommends setting the zero formed by  $R_{COMP}$  and  $C_{COMP}$  a decade smaller than the actual unity gain frequency of the regulator calculated with actual output capacitance ( $f_Z = f_T/10$ ). Use [Equation 20](#) to calculate the  $C_{COMP}$  value.

$$(EQ. 20) \quad C_{COMP} = \frac{1}{2\pi \times f_Z \times R_{COMP}}$$

- $C_{COMP}$  is the compensation capacitance.
- $R_{COMP}$  is the COMP pin resistor calculated in [Equation 15](#).
- $f_Z$  is the zero frequency set by  $R_{COMP}$  and  $C_{COMP}$ , based on the actual  $f_T$  calculated from the actual output capacitance.

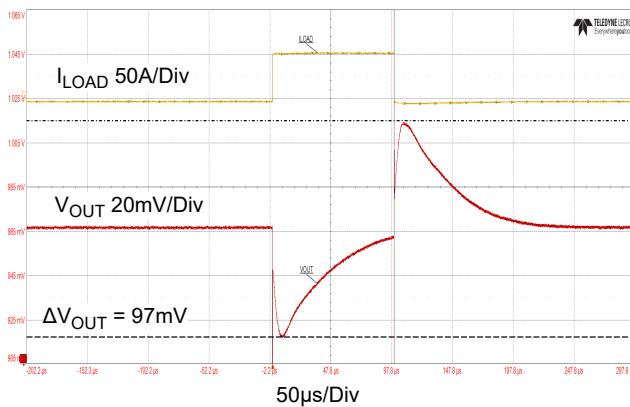
## 6.8 Pole Capacitor

A pole capacitor must be added in parallel with  $R_{COMP}$  and  $C_{COMP}$  to cancel out the zero created by the equivalent ESR and  $C_{OUT}$ . To calculate  $C_{POLE}$  use [Equation 21](#).

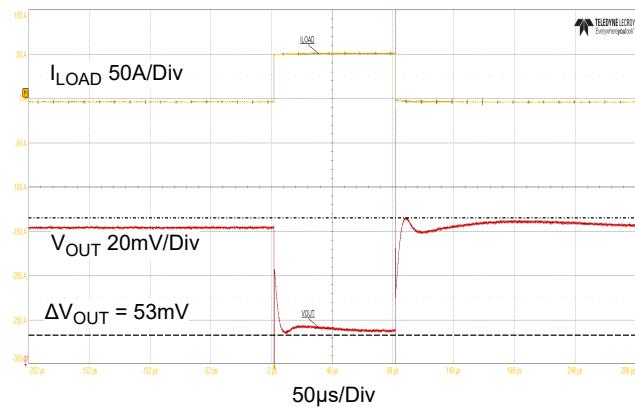
$$(EQ. 21) \quad C_{POLE} = \frac{C_{OUT} \times ESR}{R_{COMP}}$$

## 6.9 Droop Regulation Setting

Droop regulation changes the DC regulation set point inversely to the output load current, improving the transient response. Place a resistor between the DROOP and VREF pins to use droop regulation. If droop regulation is unnecessary, short the DROOP and VREF pins together. [Figure 60](#) shows the transient response with droop resistor = 0Ω, and [Figure 61](#) shows the transient response with droop resistor = 604Ω. With droop regulation, the transient response is reduced by 40%, which could allow a reduction in output capacitance if there is margin in  $\Delta V_{OUT}$ .



**Figure 60.** Transient Response without Droop Regulation



**Figure 61.** Transient Response with Droop Regulation

As the output loading increases, the current into the DROOP pin increases and generates a voltage across the resistor between the DROOP and VREF pins. This lowers the reference voltage presented to the error amplifier, effectively lowering the regulation point. The extent of the droop variation can be tuned by carefully selecting the droop resistor.

When using droop regulation, it is important to set the light load regulation point at the highest acceptable voltage using [Equation 4](#). Then, calculate the percent deviation of the regulated voltage needed to achieve the lowest acceptable voltage at the maximum DC loading. When the percentage deviation (DRP<sub>percent</sub>) is determined, use [Equation 22](#) to calculate the resistance between VREF and DROOP.

$$(EQ. 22) \quad R_{DROOP} = \frac{DRP_{percent} \times V_{REF}}{I_{DROOP} \times n}$$

- $R_{DROOP}$  is the resistance between the VREF and DROOP pins.
- DRP<sub>percent</sub> is the required droop of VOUT at full load. For example, DRP<sub>percent</sub> = 0.05 for 5% VOUT droop.
- $V_{REF}$  is the internal voltage reference, which is 0.6V (typical).
- $I_{DROOP}$  is the current into the DROOP pin (also known as the ERROR\_DRP in the EC Table), which is 19.9μA (typical).
- $n$  is the number of phases (for the ISL73847M this is either 1 or 2).

Because  $I_{DROOP}$  follows the inductor current, average the signal to get the DC load current. Use [Equation 23](#) to calculate the value of the capacitance:

$$(EQ. 23) \quad C_{DROOP} = \frac{R_{COMP} \times C_{COMP}}{R_{DROOP}}$$

- $C_{DROOP}$  is the droop capacitance.
- $R_{DROOP}$  is the resistance between the VREF and DROOP pins.

- $R_{COMP}$  is the resistor in the series RC on the COMP pin from [Equation 15](#).
- $C_{COMP}$  is the capacitor in the series RC on the COMP pin.

## 6.10 Soft-Start Capacitor Selection

The ISL73847M has an adjustable soft-start to help control the inrush current during startup. A capacitor to ground on the SS pin controls the startup dynamics of the power supply. Use [Equation 24](#) to calculate the capacitance given the required soft-start time.

$$(EQ. 24) \quad C_{SS} = \frac{t_{SS} \times I_{SS}}{V_{REF}}$$

- $C_{SS}$  is the soft-start capacitance.
- $t_{SS}$  is the required soft-start time.
- $V_{REF}$  is the reference voltage, which is 0.6V (typical).
- $I_{SS}$  is the current sourced out of the SS pin, which is 10 $\mu$ A (typical).

The output should be in regulation when the soft-start capacitor reaches the band gap voltage of 0.6V. However, the ISL73847M waits until soft-start reaches 0.9V before allowing PGOOD to reflect the output state.

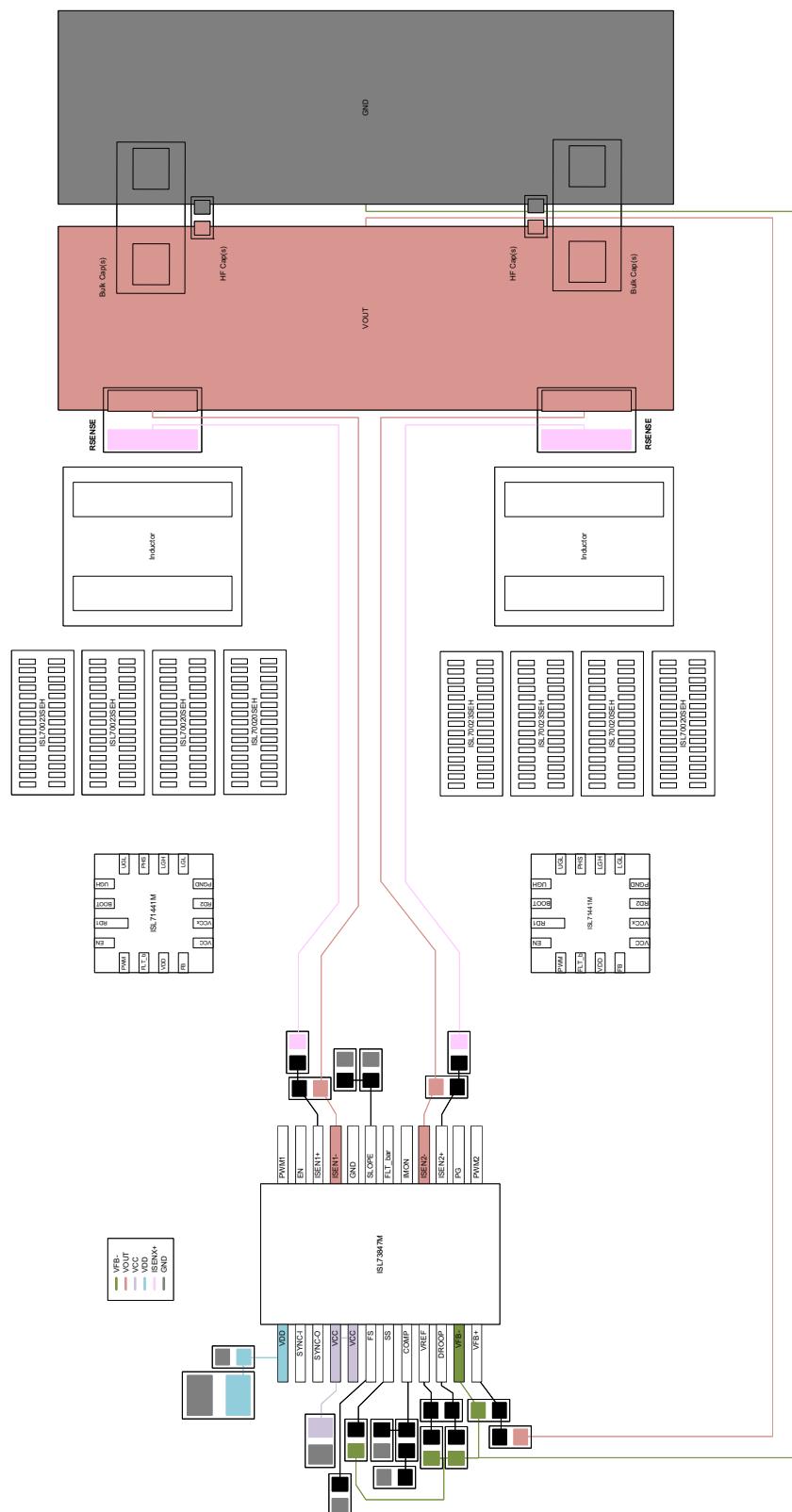
## 6.11 Layout

### 6.11.1 Layout Guidelines

The following are recommendations for the best performance on the ISL73847M:

- Place the VDD bulk and high-frequency capacitor as close as possible to the VDD pin.
- Place the feedback resistors as close as possible to the VFB+ and VFB- pins to minimize parasitic capacitance.
- Ensure that all feedback traces are routed away from noisy switching nodes.
- Place the RSENSE RC filter as close to the ISENX+ and ISENX- pins as possible.
- Place  $C_{COMP}$ ,  $R_{COMP}$ , and  $C_{POLE}$  as close as possible to the COMP pin.
- SS, DROOP, and VREF capacitors should be referenced to VFB-.
- Ensure to have a good ground plane.
- Place bulk and high-frequency PVIN capacitors close to the ISL70020SEH FETS drain (Not drawn).
- Minimize the current loop area between the PVIN bulk capacitors and GND and phase node connections
- Connect the feedback traces to the load for point-of-load (POL) regulation.
- Ensure that the traces carrying high load currents are wide enough.

## 6.11.2 Layout Example



## Figure 62. Layout Recommendations

## 7. Die and Assembly Characteristics

Table 1. Die and Assembly Related Information

Die Information	
Dimension	3710 $\mu$ m (146 mils) $\times$ 7110 $\mu$ m (280 mils) Thickness: 483 $\mu$ m $\pm$ 25 $\mu$ m (19 mils $\pm$ 1 mil)
Interface Materials	
Passivation	Type: Silicon Dioxide and silicon nitride Thickness: 24.5k $\text{\AA}$
Top Metallization	Type: Top metal/Bond Pad Composition 99.5% Al, 0.5%Cu
Backside Finish	Silicon
Process	0.25 $\mu$ m BiCMOS
Assembly Information	
Substrate Potential	Internal connection to GND
Additional Information	
Worst Case Current Density	31.36mA/ $\mu$ m
Transistor Count	268182
Weight of Packaged Device	0.64 grams

## 7.1 Metallization Mask Layout

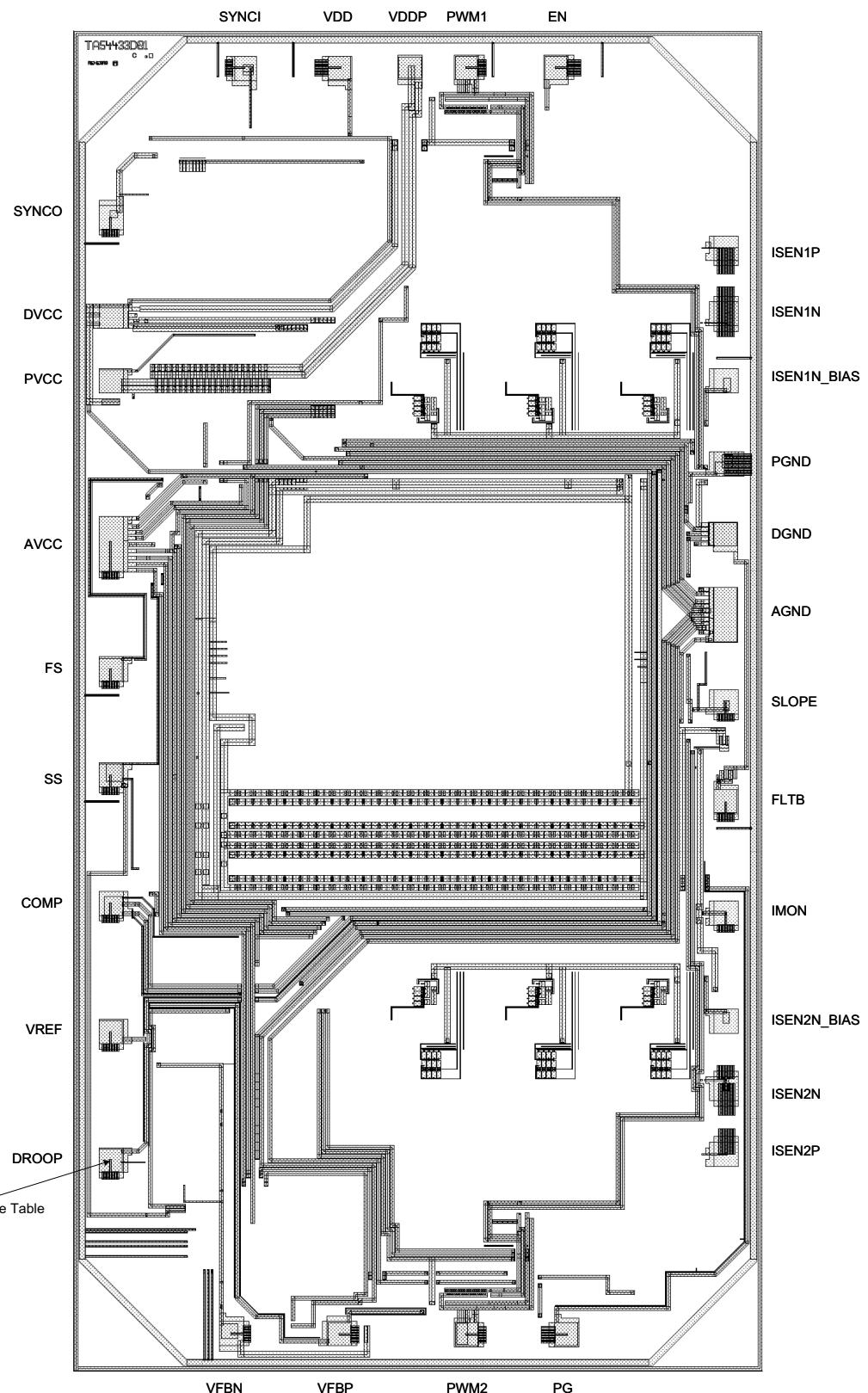


Table 2. Layout X-Y Coordinates (Centroid of Bond Pad)

Pad Name	Pad Number	Pin Number	X-Coordinate (um)	Y-Coordinate (um)	Pad Size X (um)	Pad Size Y (um)	Bond Wire Diameter (0.001")
VDDP	1	1	1559	5706	117	117	1.3
VDD	2	1	1195	5699	117	117	1.3
SYNCI	3	2	695	5699	117	117	1.3
SYNCO	4	3	0	4924	117	117	1.3
DVCC	5	4	0	4407	117	117	1.3
PVCC	6	5	0	4070	117	117	1.3
AVCC	7	5	0	3216	117	280	1.3
FS	8	6	0	2565	117	117	1.3
SS	9	7	0	2010	117	117	1.3
COMP	10	8	0	1340	117	117	1.3
VREF	11	9	0	670	117	117	1.3
DROOP	12	10	0	0	117	117	1.3
VFBN	13	11	627	-905	117	117	1.3
VFBP	14	12	1191	-905	117	117	1.3
PWM2	15	13	1855	-912	117	117	1.3
PG	16	14	2379	-912	117	117	1.3
ISEN2P	17	15	3211	31	117	117	1.3
ISEN2N	18	16	3211	373	117	117	1.3
ISEN2N_BIAS	19	16	3211	726	117	117	1.3
IMON	20	17	3211	1290	117	117	1.3
FLT	21	18	3211	1871	117	117	1.3
SLOPE	22	19	3211	2392	117	117	1.3
AGND	23	20	3211	2848	117	280	1.3
DGND	24	20	3211	3270	117	117	1.3
PGND	25	20	3211	3635	117	117	1.3
ISEN1N_BIAS	27	21	3211	4070	117	117	1.3
ISEN1N	26	21	3211	4421	117	117	1.3
ISEN1P	28	22	3211	4763	117	117	1.3
EN	29	23	2322	5706	117	117	1.3
PWM1	30	24	1855	5706	117	117	1.3

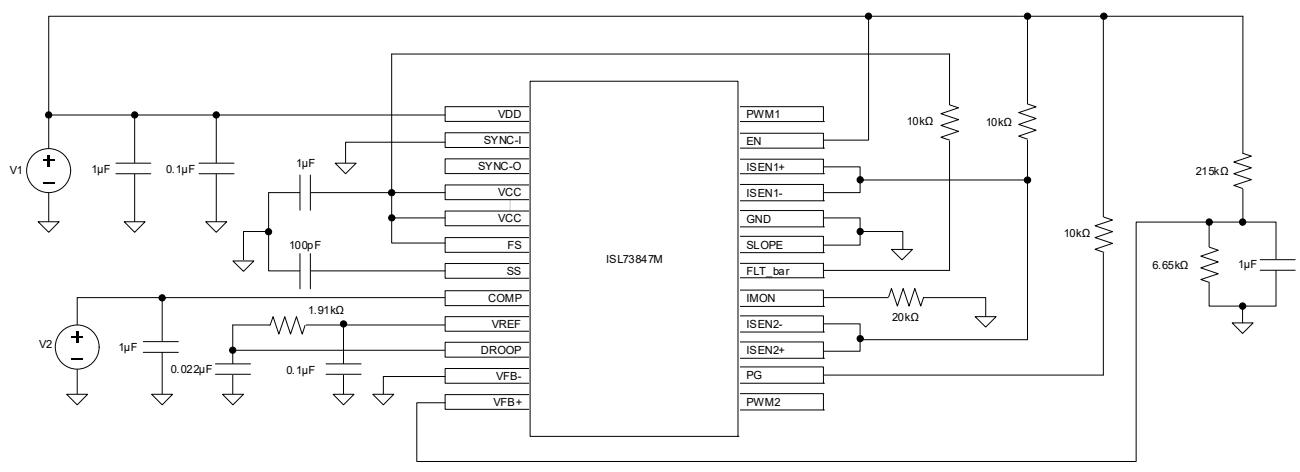
## 8. Radiation Tolerance

The ISL73847M is a radiation tolerant device for commercial space applications, Low Earth Orbit (LEO) applications, high altitude avionics, launch vehicles, and other harsh environments. This device's response to Total Ionizing Dose (TID) radiation effects and Single Event Effects (SEE) has been measured, characterized, and reported in the proceeding sections. However, TID performance is not guaranteed through radiation acceptance testing, nor is the characterized SEE performance guaranteed.

### 8.1 Total Ionizing Dose (TID) Testing

#### 8.1.1 Introduction

Total dose testing of the ISL73847M proceeded in accordance with the guidelines of MIL-STD-883 Test Method 1019. The experimental matrix consisted of 12 samples irradiated under bias and 12 samples irradiated with all pins grounded (unbiased). Three control units were used. The bias configuration is shown in [Figure 63](#).



**Figure 63. Bias Configuration**

Samples of the ISL73847M were drawn from wafer lots V6C683/4/5 and were packaged in the production 24 Ld WSOIC, Package Outline Drawing (POD) M24.3. The samples were screened to datasheet limits at room temperature only before irradiation.

Total dose irradiations were performed using a Hopewell Designs N40 panoramic vault-type low dose rate gamma ray irradiator in the Renesas Palm Bay, Florida facility. The dose rate was 0.0087rad(Si)/s (8.7mrad(Si)/s). PbAl spectrum hardening filters were used to shield the test board and devices under test against low-energy secondary gamma radiation.

Downpoints for the testing were 0krad(Si), 10krad(Si), 30krad(Si), 40krad(Si), and 50krad(Si).

All electrical testing was performed outside the irradiator using production Automated Test Equipment (ATE) with data logging of all parameters at each downpoint. All downpoint electrical testing was performed at room temperature.

### 8.1.2 Results

The plots in [Figure 64](#) through [Figure 73](#) show data for key parameters at all downpoints. The plots show the average as a function of total dose for each of the irradiation conditions; the average was used because of the relatively large sample sizes. The plots also include error bars at each down-point, representing the minimum and maximum measured values of the samples, although in some plots the error bars might not be visible due to their values compared to the scale of the graph. All parts showed excellent stability over irradiation. [Table 3](#) shows the average of other key parameters with respect to total dose in tabular form.

**Table 3. Key Parameters**

Parameter and Conditions	Symbol	Bias	0krad(Si)	10krad(Si)	30krad(Si)	50krad(Si)	Unit
Operating Supply Current $V_{DD} = 19.0V$ , $EN = 3.3V$ ; $f_{SW} = 500kHz$ and $C_L = 100pF$	$I_S$	Avg (Biased)	12.20	12.18	12.11	12.03	mA
		Avg (Unbiased)	12.22	12.17	12.04	11.88	
		Limit -	<b>9</b>	<b>9</b>	<b>9</b>	<b>9</b>	
		Limit +	<b>16</b>	<b>16</b>	<b>16</b>	<b>16</b>	
Shutdown Supply Current $V_{DD} = 19.0V$ , $EN = GND$	$I_{SD}$	Avg (Biased)	24.80	24.88	24.83	24.84	$\mu A$
		Avg (Unbiased)	24.79	24.77	24.69	24.65	
		Limit -	<b>9</b>	<b>9</b>	<b>9</b>	<b>9</b>	
		Limit +	<b>35</b>	<b>35</b>	<b>35</b>	<b>35</b>	
LDO Output Voltage Range $V_{DD} = 19.0V$ , $I_{OUT} = 0mA$ and $20mA$	$V_{CC}$ (0 mA)	Avg (Biased)	4.95	4.95	4.95	4.95	V
		Avg (Unbiased)	4.95	4.95	4.95	4.95	
	$V_{CC}$ (20 mA)	Avg (Biased)	4.94	4.94	4.94	4.94	
		Avg (Unbiased)	4.94	4.94	4.94	4.94	
	-	Limit -	<b>4.7</b>	<b>4.7</b>	<b>4.7</b>	<b>4.7</b>	
		Limit +	<b>5.3</b>	<b>5.3</b>	<b>5.3</b>	<b>5.3</b>	
LDO Dropout Voltage $V_{DD} = 4.5V$ , $I_{OUT} = 50mA$	$V_{CC_{DO}}$	Avg (Biased)	152.32	158.24	165.86	174.16	mV
		Avg (Unbiased)	151.78	153.06	155.47	158.01	
		Limit -	<b>85</b>	<b>85</b>	<b>85</b>	<b>85</b>	
		Limit +	<b>250</b>	<b>250</b>	<b>250</b>	<b>250</b>	
Set Point Voltage $V_{DD} = 19V$ , $V_{SEN1} = V_{SEN2} = 50mV$ , $V_{REF} = V_{DROOP} = 1V$ and $2V$	$V_{FB+}$ (1 V)	Avg (Biased)	0.600	0.600	0.599	0.598	V
		Avg (Unbiased)	0.600	0.600	0.600	0.601	
	$V_{FB+}$ (2 V)	Avg (Biased)	0.600	0.600	0.599	0.598	
		Avg (Unbiased)	0.600	0.600	0.600	0.600	
	-	Limit -	<b>0.592</b>	<b>0.592</b>	<b>0.592</b>	<b>0.592</b>	
		Limit +	<b>0.604</b>	<b>0.604</b>	<b>0.604</b>	<b>0.604</b>	
Error Amp Transconductance $V_{DD} = 19V$	$G_{m-EA}$	Avg (Biased)	3.61	3.60	3.61	3.59	mA/V
		Avg (Unbiased)	3.61	3.61	3.61	3.58	
	-	Limit -	<b>3.00</b>	<b>3.00</b>	<b>3.00</b>	<b>3.00</b>	
		Limit +	<b>4.00</b>	<b>4.00</b>	<b>4.00</b>	<b>4.00</b>	

Table 3. Key Parameters (Cont.)

Parameter and Conditions	Symbol	Bias	0krad(Si)	10krad(Si)	30krad(Si)	50krad(Si)	Unit
CSA Droop Transconductance $V_{DD} = 19V$ , $V_{(ISEN+ - ISEN-)} = 10mV$ and 50mV, $V_{CM} = 0.6V$	$g_m(\text{CSA,DRP})$ (CSA1)	Avg (Biased)	0.40	0.40	0.40	0.40	$\mu\text{A}/\text{mV}$
		Avg (Unbiased)	0.40	0.40	0.40	0.40	
	$g_m(\text{CSA,DRP})$ (CSA2)	Avg (Biased)	0.40	0.40	0.40	0.40	
		Avg (Unbiased)	0.40	0.40	0.40	0.40	
	-	Limit -	<b>0.38</b>	<b>0.38</b>	<b>0.38</b>	<b>0.38</b>	
		Limit +	<b>0.42</b>	<b>0.42</b>	<b>0.42</b>	<b>0.42</b>	
CSA IMON Transconductance $V_{DD} = 19V$ , $V_{(ISEN+ - ISEN-)} = 10mV$ and 50mV, $V_{CM} = 0.6V$	$g_m(\text{CSA,IMON})$ (CSA1)	Avg (Biased)	0.40	0.40	0.40	0.40	$\text{mV}$
		Avg (Unbiased)	0.40	0.40	0.40	0.40	
	$g_m(\text{CSA,IMON})$ (CSA2)	Avg (Biased)	0.40	0.40	0.40	0.40	
		Avg (Unbiased)	0.40	0.40	0.40	0.40	
	-	Limit -	<b>0.36</b>	<b>0.36</b>	<b>0.36</b>	<b>0.36</b>	
		Limit +	<b>0.47</b>	<b>0.47</b>	<b>0.47</b>	<b>0.47</b>	
500kHz Oscillator Frequency $V_{DD} = 4.5V$ and 19V, $R_{FS} = 205\text{k}\Omega$ , $EN = 3.3V$ , $R_{SYNC-O} = 100\text{k}\Omega$ to GND	$f_{OSC-0.5M}$ (4.5V)	Avg (Biased)	0.50	0.50	0.50	0.50	$\text{MHz}$
		Avg (Unbiased)	0.50	0.50	0.50	0.50	
	$f_{OSC-0.5M}$ (19V)	Avg (Biased)	0.51	0.51	0.51	0.51	
		Avg (Unbiased)	0.51	0.51	0.51	0.51	
	-	Limit -	<b>0.45</b>	<b>0.45</b>	<b>0.45</b>	<b>0.45</b>	
		Limit +	<b>0.55</b>	<b>0.55</b>	<b>0.55</b>	<b>0.55</b>	
3MHz Oscillator Frequency $V_{DD} = 4.5V$ and 19V, $R_{FS} = 205\text{k}\Omega$ , $EN = 3.3V$ , $R_{SYNC-O} = 100\text{k}\Omega$ to GND	$f_{OSC-3M}$ (4.5V)	Avg (Biased)	2.95	2.95	2.96	2.96	$\text{MHz}$
		Avg (Unbiased)	2.94	2.94	2.95	2.94	
	$f_{OSC-3M}$ (19V)	Avg (Biased)	2.93	2.93	2.94	2.94	
		Avg (Unbiased)	2.92	2.92	2.93	2.92	
	-	Limit -	<b>2.70</b>	<b>2.70</b>	<b>2.70</b>	<b>2.70</b>	
		Limit +	<b>3.30</b>	<b>3.30</b>	<b>3.30</b>	<b>3.30</b>	

### 8.1.3 Typical Radiation Performance

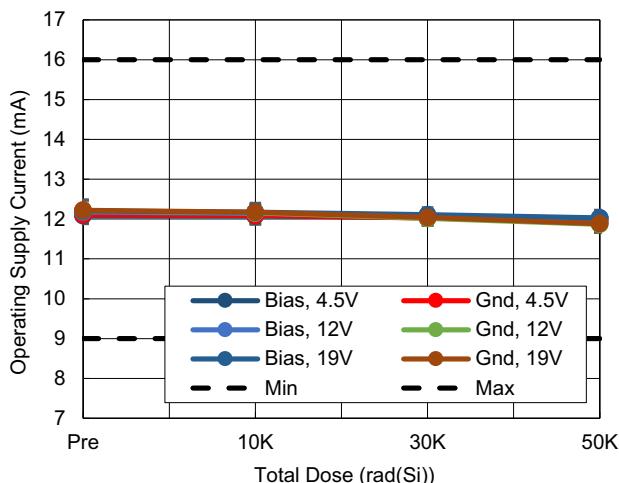


Figure 64. Operating Supply Current vs TID

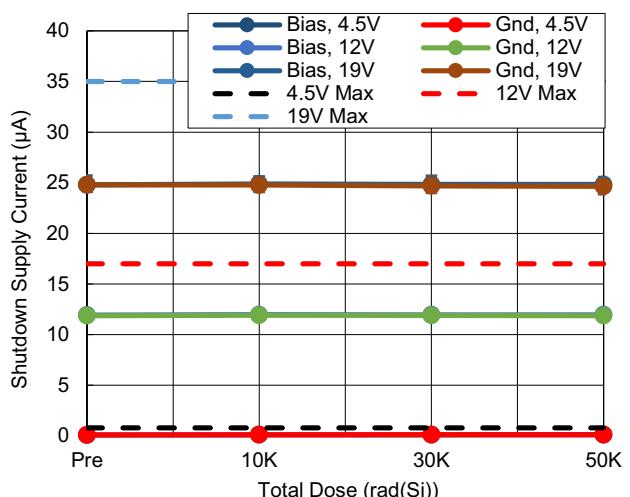


Figure 65. Shutdown Current vs TID

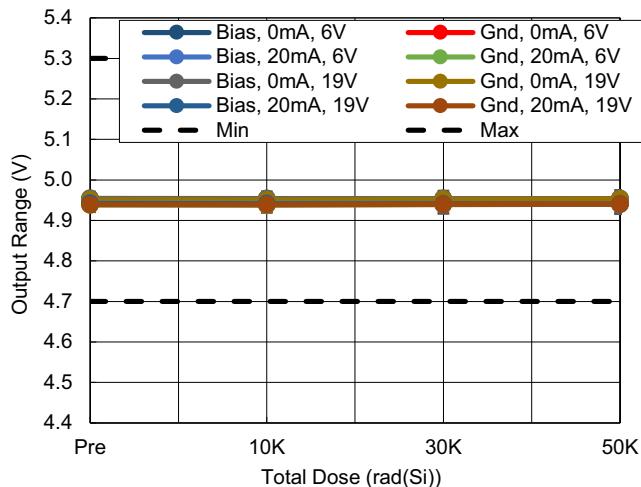


Figure 66. VCC vs TID

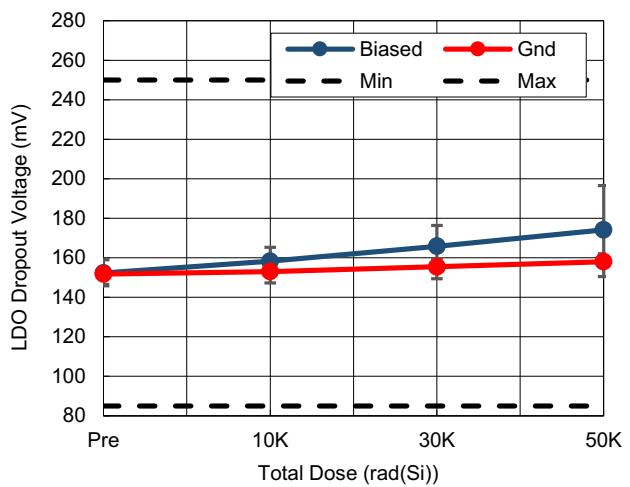


Figure 67. VCC Dropout Voltage vs TID

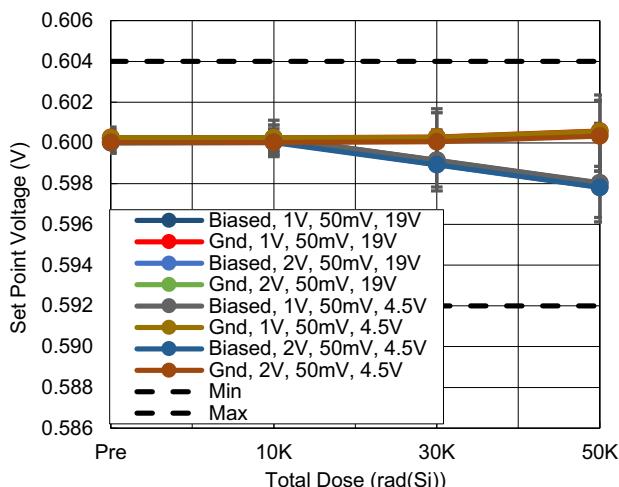


Figure 68. Set Point Voltage vs TID

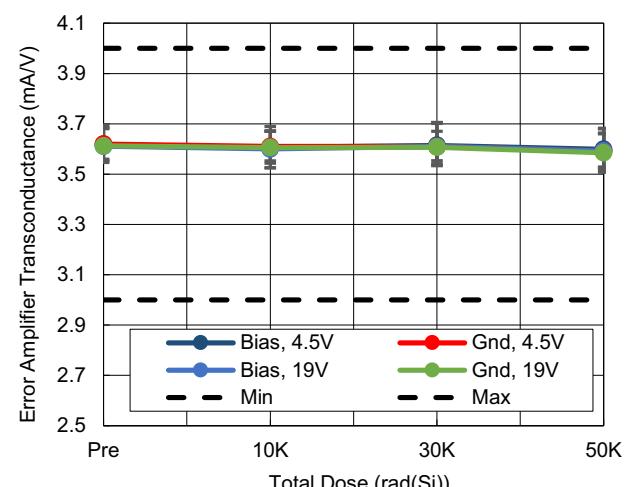


Figure 69. Transconductance vs TID

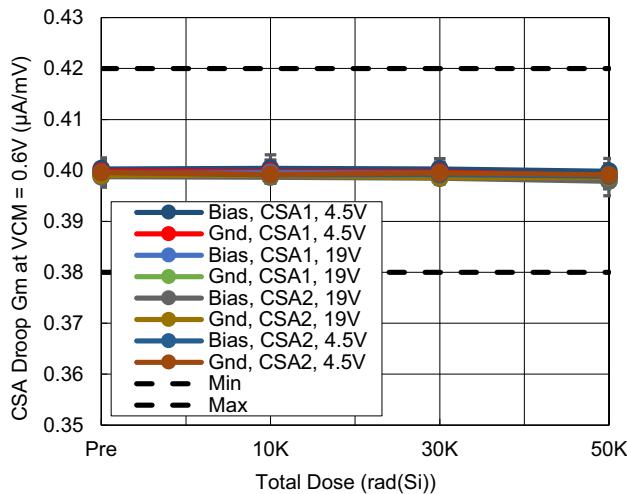


Figure 70. Droop Transconductance vs TID

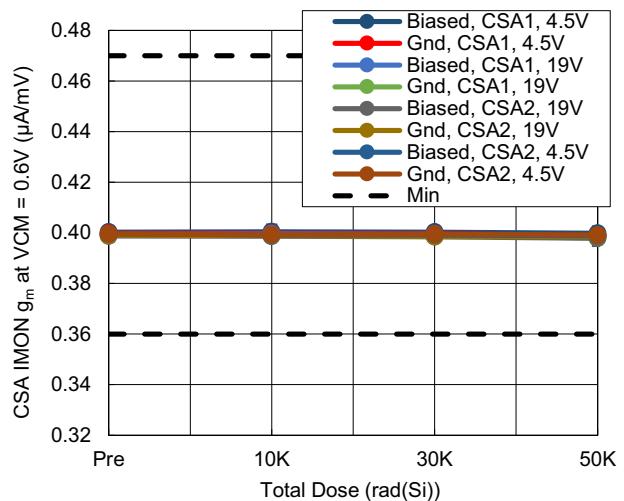
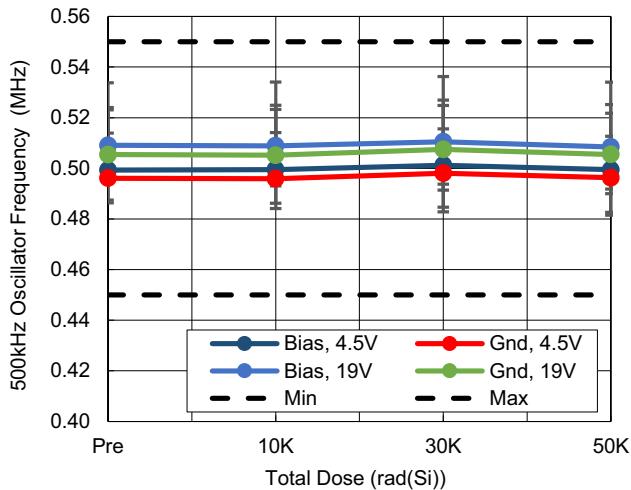
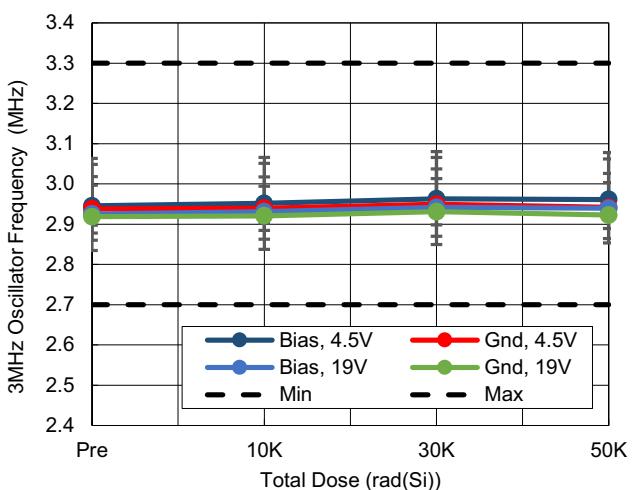


Figure 71. IMON Transconductance vs TID

Figure 72. Oscillator Frequency vs TID ( $f_{osc} = 0.5\text{MHz}$ )Figure 73. Oscillator Frequency vs TID ( $f_{osc} = 3\text{MHz}$ )

### 8.1.4 Conclusion

As shown in Table 3 and the selected graphs (Figure 64 through Figure 73), all parameters showed excellent stability over irradiation with little to no observed bias sensitivity.

## 8.2 Single-Event Effects Testing

### 8.2.1 Introduction

The intense heavy ion environment encountered in space applications can cause a variety of Single Event Effects (SEE). SEE can lead to system-level performance issues, including disruption, degradation, and destruction. For predictable and reliable space system operation, individual electronic components should be characterized to determine their SEE response. The ISL73847M exhibits no DSEE, SET or SEFI at 43MeV•cm<sup>2</sup>/mg.

### 8.2.2 SEE Test Setups

SEE testing was completed at the Texas A&M University (TAMU) Radiation Effects Facility of the Cyclotron Institute in College Station, Texas. This facility has a K500 superconducting cyclotron that can supply various ion species and flux. The testing referred to in this report was performed in April 2022 using the K500 cyclotron.

The ISL73847M DUT (Device Under Test) irradiation setup is shown in [Figure 74](#). The ISL73847M was configured for 2-phase operation at two PWM frequencies, each using a different board assembly. The board assembly configured for the switching frequency of 500kHz and  $V_{OUT} = 1.0V$  used a  $L_{OUTx}$  of  $1.0\mu\text{H}$  and  $C_{OUT}$  of  $880\mu\text{F}$  (4x KEMET T530D227M010ATE006-T with maximum ESR of  $6\text{m}\Omega$  each) The compensation component values were  $R_{COMP} = 4.22\text{k}$ ,  $C_{COMP} = 10\text{n}$ ,  $C_{POLE} = 330\text{pF}$ ,  $R_{SLOPE} = 37.4\text{k}$ , and  $R_{DROOP} = 604\Omega$ . The board assembly configured for the switching frequency of 1000kHz and  $V_{OUT} = 1.0V$  used a  $L_{OUTx}$  of  $560\text{nH}$ . The rest of the components remained the same as for the 500kHz case.

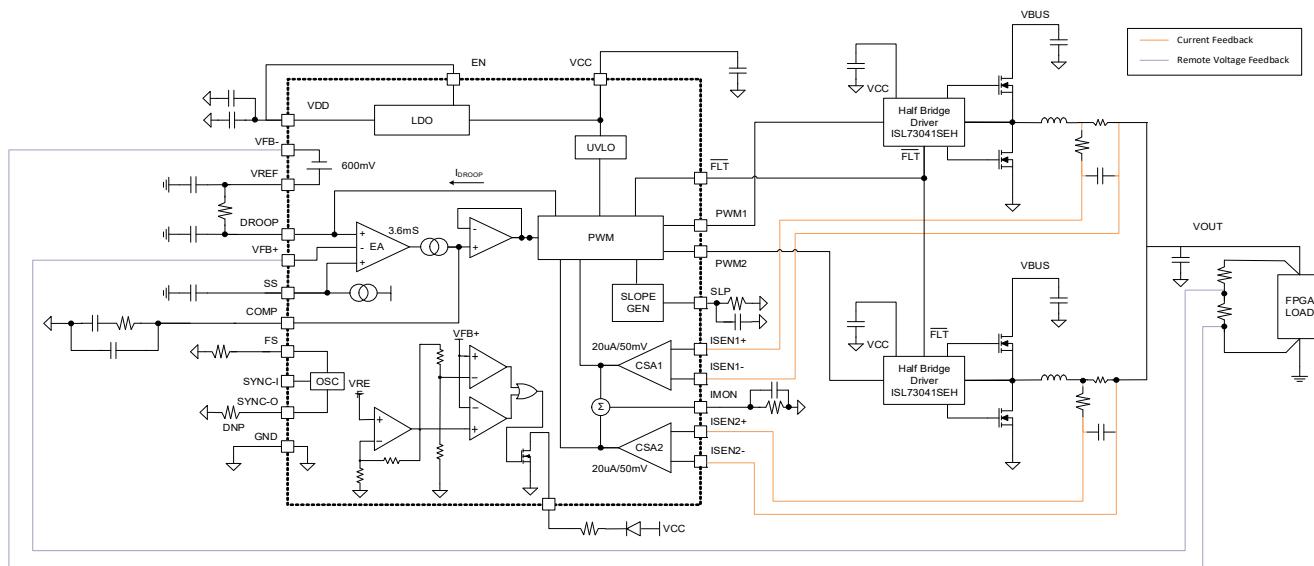


Figure 74. DUT SEE Irradiation Setup

### 8.2.3 Single Event Burnout and Latch-Up (SEB/L) Results

The ISL73847M showed no appreciable change in post output voltage, and supply currents (less than  $\pm 1\%$ ).

The ISL73847M proved to be free of DSEE, including SEL at a VDD voltage of 25.0V and a case temperature of 125°C. The device was also free of DSEE, including SEL, at a VCC voltage of 6.7V. Additionally, the device proved free of SEFIs at an ISENSE voltage of 10V. The 2-phase buck output of 1.0V was loaded to a total of 5A.

### 8.2.4 SET Results

One SET event with a deviation greater than  $\pm 20\text{mV}$  was observed, which showed a missing pulse on PWM output. The SET testing was performed on two devices at an  $f_{\text{SW}}$  of 500kHz and another two at an  $f_{\text{SW}}$  of 1000kHz. No captures, however, were seen at 500kHz during the SET testing at 25°C with a  $\pm 20\text{mV}$  window trigger on  $V_{\text{OUT}}$ .

Figure 75 shows the missing pulse on PWM2 captured during test run 413. The signals monitored during the test were:

- PWM1 and PWM2 – The drive signals.
- VREF – The voltage reference (0.6V).
- SYNC-O – The output of the internal oscillator clock.
- COMP – The output of the error amplifier.
- DROOP – The reference voltage to the error amplifier, which is modulated in proportion to the current sensed by the controller.

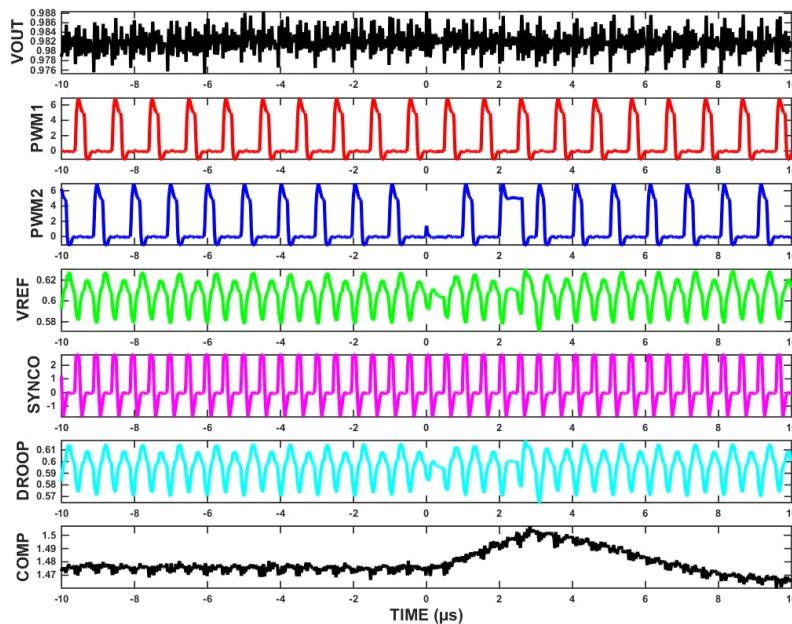


Figure 75.  $f_{\text{SW}} = 1\text{MHz}$ , trigger  $V_{\text{OUT}} \pm 20\text{mV}$

### 8.2.5 Conclusion

As shown in Figure 75, one SET event with a deviation greater than  $\pm 20\text{mV}$  was observed, which showed a missing pulse on PWM output.

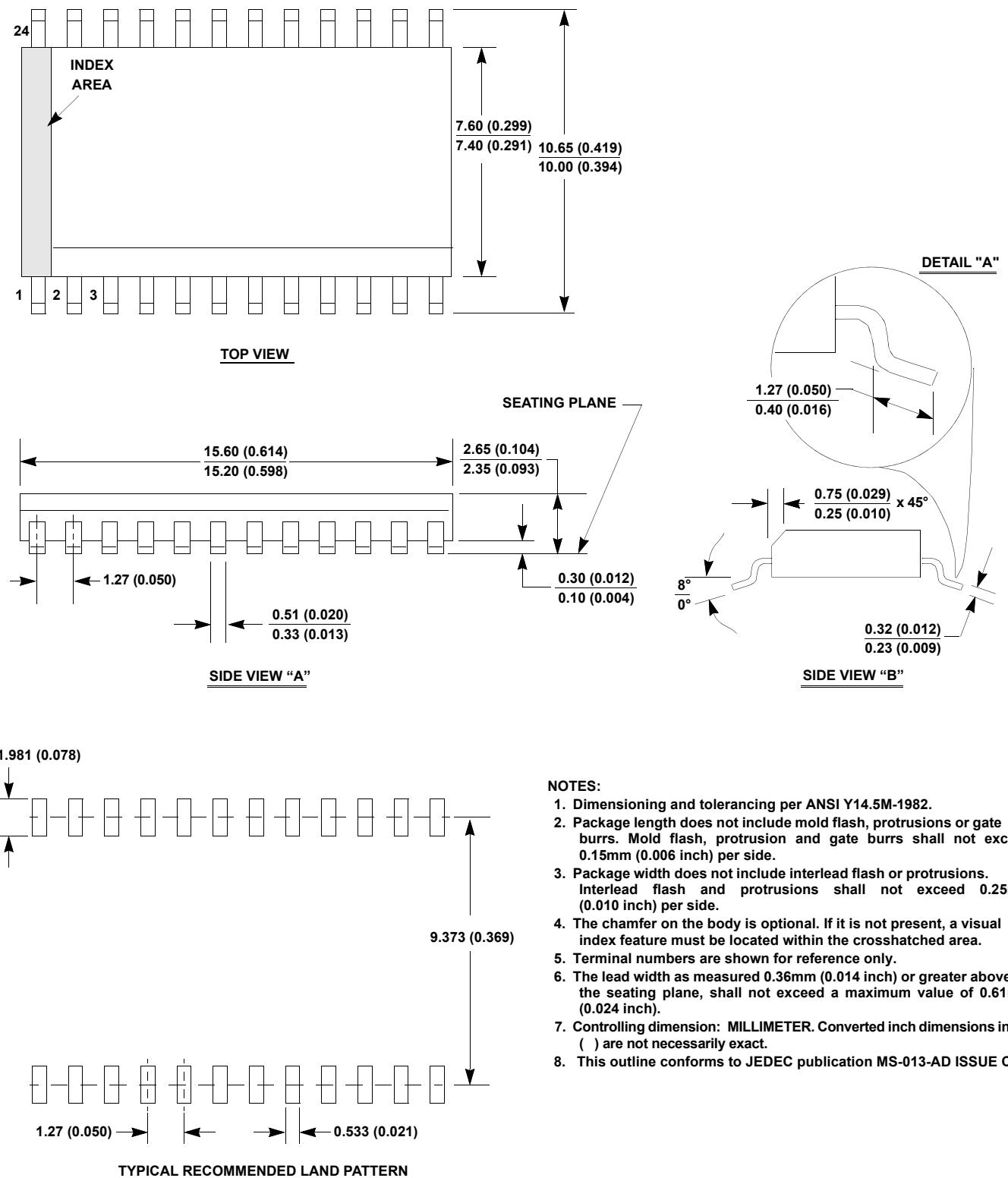
## 9. Package Outline Drawing

For the most recent package outline drawing, see [M24.3](#).

M24.3

24 Lead Wide Body Small Outline Plastic Package (SOIC)

Rev 2, 3/11



## 10. Ordering Information

Part Number <sup>[1]</sup>	Part Marking	Radiation Lot Acceptance Testing	Package Description <sup>[2]</sup> (RoHS Compliant)	MSL Rating <sup>[3]</sup>	Package Drawing	Carrier Type	Temp. Range
ISL73847M30BZ	73847 MBZ	30krad(Si)	24 Ld WSOIC Packaged Device	1	<a href="#">M24.3</a>	Tray	-55 to +125°C
ISL73847M50BZ	73847 MBZ	50krad(Si)	24 Ld WSOIC Packaged Device	1	<a href="#">M24.3</a>	Tray	-55 to +125°C
ISL73847MDEMO1Z	Dual-Phase DEMO Board (For Demonstration Purposes)						
ISL73847MDEMO2Z	Single-Phase DEMO Board (For Demonstration Purposes)						

1. These Pb-free plastic packaged products employ special Pb-free material sets; molding compounds/die attach materials and NiPdAu-Ag plate - e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J-STD-020.
2. For the Pb-Free Reflow Profile, see [TB493](#).
3. For more information about Moisture Sensitivity Level (MSL), see [TB363](#).

## 11. Revision History

Rev.	Date	Description
1.07	Feb 11, 2026	Updated Figure 62.
1.06	Nov 5, 2025	Updated the Abs Max section by removing second row and changed VCC (heavy ion environment) max from 6.3V to 6.5V.
1.05	Jul 24, 2025	Updated Page 1 information. Added the Multi-Phase Operation section.
1.04	Jan 16, 2025	Corrected package graphic in the pin assignment section.
1.03	Nov 14, 2024	Updated Figures 3, 4, and 7. Updated SYNC-I to PWM2 Delay typical from 20ns to 260. Updated SYNC-O to PWM2 Delay typical from 150ns to 20ns. Added Outgas Testing section.
1.02	Jul 24, 2024	Updated Figures 53 and 54 and related text.
1.01	May 1, 2024	Removed Table 1. Updated Peak Current Mode Control section.
1.00	Dec 7, 2023	Initial Release

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